

Parallel NOR Flash Embedded Memory

JR28F032M29EWXX; PZ28F032M29EWXX; JS28F064M29EWXX PC28F064M29EWXX; JR28F064M29EWXX; PZ28F064M29EWXX JS28F128M29EWXX; PC28F128M29EWXX; RC28F128M29EWXX

Features

- · Supply voltage
 - $V_{CC} = 2.7-3.6V$ (program, erase, read)
 - $V_{CCO} = 1.65-3.6V (I/O buffers)$
- · Asynchronous random or page read
 - Page size: 8 words or 16 bytes
 - Page access: 25ns
 - Random access: 60ns (BGA); 70ns (TSOP)
- Buffer program: 256-word MAX program buffer
- Program time
 - 0.56µs per byte (1.8 MB/s TYP when using 256word buffer size in buffer program without V_{PPH})
 - 0.31µs per byte (3.2 MB/s TYP when using 256word buffer size in buffer program with V_{PPH})
- Memory organization
 - 32Mb: 64 main blocks, 64KB each, or eight 8KB boot blocks (top or bottom) and 63 main blocks, 64KB each
 - 64Mb: 128 main blocks, 64KB each, or eight 8KB boot blocks (top or bottom) and 127 main blocks, 64 KB each
 - 128Mb: 128 main blocks, 128KB each
- Program/erase controller
 - Embedded byte/word program algorithms
- · Program/erase suspend and resume capability
 - READ operation on any block during a PRO-GRAM SUSPEND operation
 - READ or PROGRAM operation on one block during an ERASE SUSPEND operation on another block
- BLANK CHECK operation to verify an erased block
- Unlock bypass, block erase, chip erase, and write to buffer capability
 - Fast buffered/batch programming
 - Fast block and chip erase

- V_{PP}/WP# pin protection
 - V_{PPH} voltage on V_{PP} to accelerate programming performance
 - Protects highest/lowest block (H/L uniform) or top/bottom two blocks (T/B boot)
- Software protection
- Volatile protection
- Nonvolatile protection
- Password protection
- Password access
- Extended memory block
 - 128-word (256-byte) block for permanent secure identification
 - Program or lock implemented at the factory or by the customer
- Low-power consumption: Standby mode
- JESD47H-compliant
 - 100,000 minimum ERASE cycles per block
 - Data retention: 20 years (TYP)
- 65nm single-bit cell process technology
- Packages (JEDEC-standard)
 - 56-pin TSOP (128Mb, 64Mb)
 - 48-pin TSOP (64Mb, 32Mb)
 - 64-ball FBGA (128Mb, 64Mb)
- 48-ball BGA (64Mb, 32Mb)Green packages available
 - RoHS-compliant
 - Halogen-free
- Operating temperature
 - Ambient: -40°C to +85°C



Part Numbering Information

This product is available with the prelocked extended memory block. Devices are shipped from the factory with memory content bits erased to 1. For a list of available options, such as packages or high/low protection, or for further information, contact your Micron sales representative.

Table 1: Part Number Information

Part Number Category	Category Details				
Package	JS = 56-pin TSOP, 14mm x 20mm, lead-free, halogen-free, RoHS-compliant				
	PC = 64-ball Fortified BGA, 11mm x 13mm, lead-free, halogen-free, RoHS-compliant				
	RC = 64-ball Fortified BGA, 11mm x 13mm, leaded				
	JR = 48-pin TSOP, 12mm x 20mm, lead-free, halogen-free, RoHS-compliant				
	PZ = 48-ball BGA, 6mm x 8mm, lead-free, halogen-free, RoHS-compliant				
Product designator	28F = Parallel NOR interface				
Density	128 = 128Mb				
	064 = 64Mb				
	032 = 32Mb				
Device type	M29EW = Embedded Flash memory (3V core, page read)				
Device function	H = Highest block protected by V _{PP} /WP#; uniform block				
	L = Lowest block protected by V _{PP} /WP#; uniform block				
	B = Bottom boot; bottom two blocks protected by V _{PP} /WP#				
	T = Top boot; top two blocks protected by $V_{PP}/WP#$				
Features	A/B/F/X or an asterisk (*) = Combination of features, including packing media, security features, and specific customer request information				

Valid M29EW Part Number Combinations

Table 2: Standard Part Numbers by Density, Medium, and Package

ity	Ē	Package									
Density	Medi	JS	PC	RC	JR	PZ					
32Mb	Tray	-	-	_	JR28F032M29EWHA	PZ28F032M29EWHA					
					JR28F032M29EWLA	PZ28F032M29EWLA					
					JR28F032M29EWBA	PZ28F032M29EWBA					
					JR28F032M29EWTA	PZ28F032M29EWTA					
	Tape	-	-	_	JR28F032M29EWBB	PZ28F032M29EWBB					
	and				JR28F032M29EWTB						
	reel										

Table 2: Standard Part Numbers by Density, Medium, and Package (Continued)

iţ	2	Package								
Density	Medium	JS	PC	RC	JR	PZ				
64Mb	Tray	JS28F064M29EWHA	PC28F064M29EWHA	_	JR28F064M29EWHA	PZ28F064M29EWHA				
		JS28F064M29EWLA	PC28F064M29EWLA		JR28F064M29EWLA	PZ28F064M29EWLA				
		JS28F064M29EWBA	PC28F064M29EWBA		JR28F064M29EWBA	PZ28F064M29EWBA				
		JS28F064M29EWTA	PC28F064M29EWTA		JR28F064M29EWTA	PZ28F064M29EWTA				
	Tape	JS28F064M29EWLB	_	_	JR28F064M29EWHB	PZ28F064M29EWBB				
	and				JR28F064M29EWLB					
	reel				JR28F064M29EWTB					
128Mb	Tray	JS28F128M29EWHF	PC28F128M29EWHF	RC28F128M29EWHF	_	_				
		JS28F128M29EWLA	PC28F128M29EWLA	RC28F128M29EWLA						
	Tape	-	_	_	_	_				
	and									
	reel									

Table 3: Part Numbers with Security Features by Density, Medium, and Package

		Package				
Density	Medium	PC	PZ			
64Mb	Tray	PC28F064M29EWHX	PZ28F064M29EWHX			
		PC28F064M29EWLX	PZ28F064M29EWLX			
		PC28F064M29EWBX	PZ28F064M29EWBX			
		PC28F064M29EWTX	PZ28F064M29EWTX			
	Tape and Reel	PC28F064M29EWTY	_			
128Mb	Tray	PC28F128M29EWHX	-			
		PC28F128M29EWLX				
	Tape and Reel	-	-			

Note: 1. This data sheet covers only standard parts. For security parts, contact your local Micron sales representative.



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32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash General Description

General Description

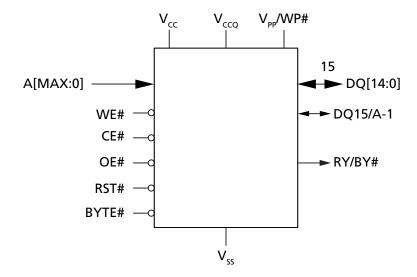
The M29EW is an asynchronous, parallel NOR Flash memory device manufactured on 65nm single-bit cell (SBC) technology. READ, ERASE, and PROGRAM operations are performed using a single low-voltage supply. Upon power-up, the device defaults to read array mode.

The main memory array is divided into uniform blocks that can be erased independently so that valid data can be preserved while old data is purged. PROGRAM and ERASE commands are written to the command interface of the memory. An on-chip program/ erase controller simplifies the process of programming or erasing the memory by taking care of all special operations required to update the memory contents. The end of a PROGRAM or ERASE operation can be detected and any error condition can be identified. The command set required to control the device is consistent with JEDEC standards.

CE#, OE#, and WE# control the bus operation of the device and enable a simple connection to most microprocessors, often without additional logic.

The M29EW supports asynchronous random read and page read from all blocks of the array. It also features an internal program buffer that improves throughput by programming 256 words via one command sequence. The device contains a 128-word extended memory block which overlaps addresses with array block 0. The user can program this additional space and then protect it to permanently secure the contents. The device also features different levels of hardware and software protection to secure blocks from unwanted modification.

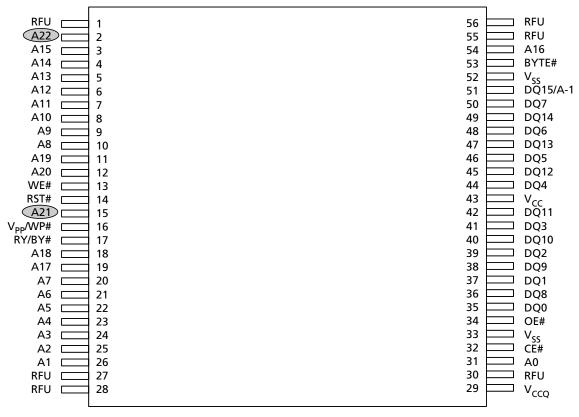
Figure 1: Logic Diagram





Signal Assignments

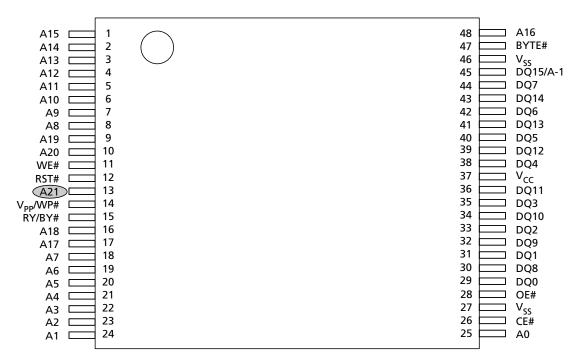
Figure 2: 56-Pin TSOP (Top View)



Notes:

- 1. A-1 is the least significant address bit in x8 mode.
- 2. A21 is valid for 64Mb and above; otherwise, it is RFU.
- 3. A22 is valid for 128Mb and above; otherwise, it is RFU.
- 4. RFU = Reserved for future use.

Figure 3: 48-Pin TSOP (Top View)

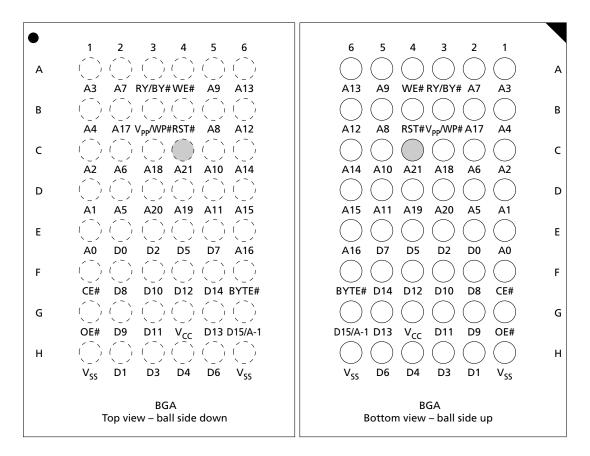


- Notes: 1. A-1 is the least significant address bit in x8 mode.
 - 2. A21 is valid for 64Mb and above; otherwise, it is RFU.

10

3. RFU = Reserved for future use.

Figure 4: 48-Ball BGA (Top and Bottom Views)

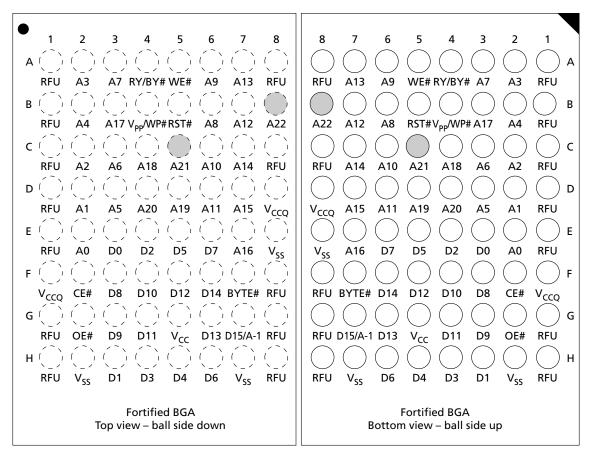


Notes: 1. A-1 is the least significant address bit in x8 mode.

2. A21 is valid for 64Mb and above; otherwise, it is RFU.

3. RFU = Reserved for future use.

Figure 5: 64-Ball Fortified BGA (Top and Bottom Views)



Notes:

- 1. A-1 is the least significant address bit in x8 mode.
- 2. A21 is valid for 64Mb and above; otherwise, it is RFU.
- 3. A22 is valid for 128Mb and above; otherwise, it is RFU.
- 4. RFU = Reserved for future use.



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Signal Descriptions

Signal Descriptions

The signal description table below is a comprehensive list of signals for this device family. All signals listed may not be supported on this device. See Signal Assignments for information specific to this device.

Table 4: Signal Descriptions

Name	Туре	Description
A[MAX:0]	Input	Address: Selects the cells in the array to access during READ operations. During WRITE operations, they control the commands sent to the command interface of the program/erase controller.
CE#	Input	Chip enable: Activates the device, enabling READ and WRITE operations to be performed. When CE# is HIGH, the device goes to standby and data outputs are at HIGH-Z.
OE#	Input	Output enable: Controls the bus READ operation.
WE#	Input	Write enable: Controls the bus WRITE operation of the command interface.
V _{PP} /WP#	Input	V_{PP} /Write Protect: Provides WRITE PROTECT function and V_{PPH} function. These functions protect the lowest or highest block or top two blocks or bottom two blocks, enable the device to enter unlock bypass mode and accelerate program speed, respectively. (Refer to Hardware Protection, Bypass Operations, and Program Operations for details.) A 0.1μF capacitor should be connected between V_{PP} /WP# and V_{SS} to decouple the current surges from the power supply when V_{PPH} is applied. The PCB track widths must be sufficient to carry the currents required during PROGRAM and ERASE operation when V_{PPH} is applied (see DC Characteristics).
BYTE#	Input	Byte/word organization select: Switches between x8 and x16 bus modes. When BYTE# is LOW, the device is in x8 mode; when HIGH, the device is in x16 mode.
RST#	Input	Reset: Applies a hardware reset to the device, which is achieved by holding RST# LOW for at least ^t PLPX. After RST# goes HIGH, the device is ready for READ and WRITE operations (after ^t PHEL or ^t RHEL, whichever occurs last). See RESET AC Specifications for more details.
DQ[7:0]	I/O	Data I/O: Outputs the data stored at the selected address during a READ operation. During WRITE operations, they represent the commands sent to the command interface of the internal state machine.
DQ[14:8]	I/O	Data I/O: Outputs the data stored at the selected address during a READ operation when BYTE# is HIGH. When BYTE# is LOW, these pins are not used and are High-Z. During WRITE operations, these bits are not used. When reading the status register, these bits should be ignored.
DQ15/A-1	I/O	Data I/O or address input: When the device operates in x16 bus mode, this pin behaves as data I/O, together with DQ[14:8]. When the device operates in x8 bus mode, this pin behaves as the least significant bit of the address. Except where stated explicitly otherwise, DQ15 = data I/O (x16 mode); A-1 = address input (x8 mode).

Table 4: Signal Descriptions (Continued)

Name	Туре	Description
RY/BY#	Output	Ready busy: Open-drain output that can be used to identify when the device is performing a PROGRAM or ERASE operation. During PROGRAM or ERASE operations, RY/BY# is LOW, and is High-Z during read mode, auto select mode, and erase suspend mode. After a hardware reset, READ and WRITE operations cannot begin until RY/BY# goes High-Z (see RESET AC Specifications for more details). The use of an open-drain output enables the RY/BY# pins from several devices to be connected to a single pull-up resistor to V_{CCQ} . A low value will then indicate that one (or more) of the devices is (are) busy. A 10K Ohm or bigger resistor is recommended as pull-up resistor to achieve 0.1V V_{OL} .
V _{CC}	Supply	Supply voltage: Provides the power supply for READ, PROGRAM, and ERASE operations. The command interface is disabled when $V_{CC} <= V_{LKO}$. This prevents WRITE operations from accidentally damaging the data during power-up, power-down, and power surges. If the program/erase controller is programming or erasing during this time, then the operation aborts and the contents being altered will be invalid. A $0.1\mu F$ capacitor should be connected between V_{CC} and V_{SS} to decouple the current surges from the power supply. The PCB track widths must be sufficient to carry the currents required during PROGRAM and ERASE operations (see DC Characteristics).
V _{CCQ}	Supply	I/O supply voltage: Provides the power supply to the I/O pins and enables all outputs to be powered independently from V_{CC} .
V _{SS}	Supply	Ground: All V _{SS} pins must be connected to the system ground.
RFU	-	Reserved for future use: RFUs should be not connected.

Memory Organization

Memory Configuration

The 32Mb device memory array (x8/x16) is divided into 63 main blocks (64KB each) and 8 top or bottom boot blocks (8KB each). It is also divided into 64 main uniform blocks (64KB each).

The 64Mb device memory array (x8/x16) is divided into 127 main blocks (64KB each) and 8 top or bottom boot blocks (8KB each). It is also divided into 128 main uniform blocks (64KB each).

The 128Mb device memory array (x8/x16) is divided into 128 main uniform blocks (128KB each).

Memory Map - 32Mb

Table 5: 32Mb Memory Map - x8 Top and Bottom Boot [70:0]

	Block	Address Range	e (x8 Top Boot)		Block	Address Range (x8 Bottom Boot)
Block	Size	Start	End	Block	Size	Start	End
70	8KB	003F E000	003F FFFF	70	64KB	003F 0000	003F FFFF
69		003F C000	003F DFFF	69		003E 0000	003E FFFF
68		003F A000	003F BFFF	68		003D 0000	003D FFFF
67		003F 8000	003F 9FFF	:	i i	:	:
66		003F 6000	003F 7FFF	8	64KB	0001 0000	0001 FFFF
65		003F 4000	003F 5FFF	7	8KB	0000 E000	0000 FFFF
64		003F 2000	003F 3FFF	6		0000 C000	0000 DFFF
63		003F 0000	003F 1FFF	5		0000 A000	0000 BFFF
62	64KB	003E 0000	003E FFFF	4		0000 8000	0000 9FFF
:	i	i i	i i	3		0000 6000	0000 7FFF
2	64KB	0002 0000	0002 FFFF	2		0000 4000	0000 5FFF
1		0001 0000	0001 FFFF	1]	0000 2000	0000 3FFF
0		0000 0000	0000 FFFF	0		0000 0000	0000 1FFF

Table 6: 32Mb Memory Map - x16 Top and Bottom Boot [70:0]

	Block	Address Range	(x16 Top Boot)		Block	Address Range (x16 Bottom Boot)
Block	Size	Start	End	Block	Size	Start	End
70	4KW	001F F000	001F FFFF	70	32KW	001F 8000	001F FFFF
69		001F E000	001F EFFF	69		001F 0000	001F 7FFF
68		001F D000	001F DFFF	68		001E 8000	001E FFFF
67		001F C000	001F CFFF	:	i	i i	:
66		001F B000	001F BFFF	8	32KW	0000 8000	0000 FFFF
65		001F A000	001F AFFF	7	4KW	0000 7000	0000 7FFF
64		001F 9000	001F 9FFF	6		0000 6000	0000 6FFF
63		001F 8000	001F 8FFF	5		0000 5000	0000 5FFF
62	32KW	001F 0000	001F 7FFF	4		0000 4000	0000 4FFF
i	÷	:	:	3		0000 3000	0000 3FFF
2	32KW	0001 0000	0001 7FFF	2]	0000 2000	0000 2FFF
1		0000 8000	0000 FFFF	1]	0000 1000	0000 1FFF
0		0000 0000	0000 7FFF	0		0000 0000	0000 0FFF



Table 7: 32Mb Memory Map - x8/x16 Uniform Blocks [63:0]

	Block	Address R	lange (x8)		Block	Address R	ange (x16)
Block	Size	Start	End	Block	Size	Start	End
63	64KB	03F 0000h	F 0000h 03F FFFFh		32KW	01F 8000h	01F FFFFh
i i		:	:	i i		:	i:
0		000 0000h	000 FFFFh	0]	000 0000h	000 7FFFh

Memory Map - 64Mb

Table 8: 64Mb Memory Map - x8 Top and Bottom Boot [134:0]

	Block	Address Range	(x8 Top Boot)		Block	Address Range (x8 Bottom Boot)
Block	Size	Start	End	Block	Size	Start	End
134	8KB	007F E000	007F FFFF	134	64KB	007F 0000	007F FFFF
133		007F C000	007F DFFF	133		007E 0000	007E FFFF
132		007F A000	007F BFFF	132		007D 0000	007D FFFF
131		007F 8000	007F 9FFF	:	:	:	:
130		007F 6000	007F 7FFF	8	64KB	0001 0000	0001 FFFF
129		007F 4000	007F 5FFF	7	8KB	0000 E000	0000 FFFF
128		007F 2000	007F 3FFF	6		0000 C000	0000 DFFF
127		007F 0000	007F 1FFF	5		0000 A000	0000 BFFF
126	64KB	007E 0000	007E FFFF	4		0000 8000	0000 9FFF
i	÷	:	:	3		0000 6000	0000 7FFF
2	64KB	0002 0000	0002 FFFF	2		0000 4000	0000 5FFF
1		0001 0000	0001 FFFF	1		0000 2000	0000 3FFF
0		0000 0000	0000 FFFF	0		0000 0000	0000 1FFF

Table 9: 64Mb Memory Map - x16 Top and Bottom Boot [134:0]

	Block	Address Range	(x16 Top Boot)		Block	Address Range ((16 Bottom Boot)
Block	Size	Start	End	Block	Size	Start	End
134	4KW	003F F000	003F FFFF	134	32KW	003F 8000	003F FFFF
133		003F E000	003F EFFF	133		003F 0000	003F 7FFF
132		003F D000	003F DFFF	132		003E 8000	003E FFFF
131		003F C000	003F CFFF	:	÷	i i	:
130		003F B000	003F BFFF	8	32KW	0000 8000	0000 FFFF
129		003F A000	003F AFFF	7	4KW	0000 7000	0000 7FFF
128		003F 9000	003F 9FFF	6		0000 6000	0000 6FFF
127		003F 8000	003F 8FFF	5		0000 5000	0000 5FFF
126	32KW	003F 0000	003F 7FFF	4		0000 4000	0000 4FFF
i	÷	:	:	3		0000 3000	0000 3FFF
2	32KW	0001 0000	0001 7FFF	2		0000 2000	0000 2FFF
1		0000 8000	0000 FFFF	1		0000 1000	0000 1FFF
0		0000 0000	0000 7FFF	0		0000 0000	0000 0FFF



Table 10: 64Mb Memory Map - x8/x16 Uniform Blocks [127:0]

	Block	Address Range (x8)			Block	Address Range (x16)			
Block	Size	Start	End	Block	Size	Start	End		
127	64KB	07F 0000h	07F FFFFh	127	32KW	03F 8000h	03F FFFFh		
÷		i.	:	÷		:	i.		
63		03F 0000h	03F FFFFh	63		01F 8000h	01F FFFFh		
÷		i.	:	÷		:	i i		
0		000 0000h	000 FFFFh	0]	000 0000h	000 7FFFh		

Memory Map - 128Mb

Table 11: 128Mb Memory Map - x8/x16 Uniform Blocks [127:0]

	Block	Address R	lange (x8)		Block	Address Range (x16)			
Block	Size	Start	End	Block	Size	Start	End		
127	128KB	0FE 0000h	0FF FFFFh	127	64KW	07F 0000h	07F FFFFh		
i		i i	:	:]	÷	:		
63		07E 0000h	07F FFFFh	63		03F 0000h	03F FFFFh		
i i		i i	:	:]	:	:		
0		000 0000h	001 FFFFh	0]	000 0000h	000 FFFFh		

32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Bus Operations

Bus Operations

Table 12: Bus Operations

Notes 1 and 2 apply to entire table

							8-Bit Mode	16-Bit	Mode	
Operation	CE#	OE#	WE#	RST#	V _{PP} /WP#	A[MAX:0], DQ15/A-1	DQ[14:8]	DQ[7:0]	A[MAX:0]	DQ15/A-1, DQ[14:0]
READ	L	L	Н	Н	Х	Byte address	High-Z	Data output	Word address	Data output
WRITE	L	Н	L	Н	H ³	Command address	High-Z	Data input ⁴	Command address	Data input ⁴
STANDBY	Н	Х	Х	Н	Н	Х	High-Z	High-Z	х	High-Z
OUTPUT DISABLE	L	Н	Н	Н	Х	Х	High-Z	High-Z	Х	High-Z
RESET	Х	Х	Х	L	Х	X	High-Z	High-Z	х	High-Z

Notes:

- 1. Typical glitches of less than 3ns on CE#, WE#, and RST# are ignored by the device and do not affect bus operations.
- 2. $H = Logic level HIGH (V_{IH})$; $L = Logic level LOW (V_{IL})$; X = HIGH or LOW.
- 3. If WP# is LOW, then the highest or the lowest block remains protected, or the top two blocks or the bottom two blocks, depending on line item.
- 4. Data input is required when issuing a command sequence or when performing data polling or block protection.

Read

Bus READ operations read from the memory cells, registers, or CFI space. To accelerate the READ operation, the memory array can be read in page mode where data is internally read and stored in a page buffer.

Page size is 8 words (16 bytes) and is addressed by address inputs A[2:0] in x16 bus mode and A[2:0] plus DQ15/A-1 in x8 bus mode. The extended memory blocks and CFI area do not support page read mode.

A valid bus READ operation involves setting the desired address on the address inputs, taking CE# and OE# LOW, and holding WE# HIGH. The data I/Os will output the value. (See AC Characteristics for details about when the output becomes valid.)

Write

Bus WRITE operations write to the command interface. A valid bus WRITE operation begins by setting the desired address on the address inputs. The address inputs are latched by the command interface on the falling edge of CE# or WE#, whichever occurs last. The data I/Os are latched by the command interface on the rising edge of CE# or WE#, whichever occurs first. OE# must remain HIGH during the entire bus WRITE operation. (See AC Characteristics for timing requirement details.)

Standby

Driving CE# HIGH in read mode causes the device to enter standby, and data I/Os to be High-Z. To reduce the supply current to the standby supply current (I_{CC2}), CE# must be held within V_{CC} ±0.3V. (See DC Characteristics.)



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Bus Operations

During PROGRAM or ERASE operations the device will continue to use the program/ erase supply current (I_{CC3}) until the operation completes.

Output Disable

Data I/Os are High-Z when OE# is HIGH.

Reset

During reset mode the device is deselected and the outputs are High-Z. The device is in reset mode when RST# is LOW. The power consumption is reduced to the standby level, independently from CE#, OE#, or WE# inputs.



Registers

Status Register

Table 13: Status Register Bit Definitions

Note 1 applies to entire table

Bit	Name	Settings	Description	Notes
DQ7	Data polling bit	0 or 1, depending on operations	Monitors whether the program/erase controller has successfully completed its operation, or has responded to an ERASE SUSPEND operation.	2, 3, 4
DQ6	Toggle bit	Toggles: 0 to 1; 1 to 0; and so on	Monitors whether the program/erase controller has successfully completed its operations, or has responded to an ERASE SUSPEND operation. During a PROGRAM/ERASE operation, DQ6 toggles from 0 to 1, 1 to 0, and so on, with each successive READ operation from any address.	3, 4, 5
DQ5	Error bit	0 = Success 1 = Failure	Identifies errors detected by the program/erase controller. DQ5 is set to 1 when a PROGRAM, BLOCK ERASE, or CHIP ERASE operation fails to write the correct data to the memory, or when a BLANK CHECK operation fails.	4, 6
DQ3	Erase timer bit	0 = Erase not in progress 1 = Erase in progress	Identifies the start of program/erase controller operation during a BLOCK ERASE command. Before the program/erase controller starts, this bit set to 0, and additional blocks to be erased can be written to the command interface.	4
DQ2	Alternative toggle bit	Toggles: 0 to 1; 1 to 0; and so on	Monitors the program/erase controller during ERASE operations. During CHIP ERASE, BLOCK ERASE, and ERASE SUSPEND operations, DQ2 toggles from 0 to 1, 1 to 0, and so on, with each successive READ operation from addresses within the blocks being erased.	3, 4
DQ1	Buffered program abort bit	1 = Abort	Indicates a BUFFER PROGRAM operation abort. The BUFFERED PROGRAM ABORT and RESET command must be issued to return the device to read mode (see WRITE TO BUFFER PROGRAM command).	

Notes:

- 1. The status register can be read during PROGRAM, ERASE, or ERASE SUSPEND operations; the READ operation outputs data on DQ[7:0].
- 2. For a PROGRAM operation in progress, DQ7 outputs the complement of the bit being programmed. For a READ operation from the address previously programmed successfully, DQ7 outputs existing DQ7 data. For a READ operation from addresses with blocks to be erased while an ERASE SUSPEND operation is in progress, DQ7 outputs 0; upon successful completion of the ERASE SUSPEND operation, DQ7 outputs 1. For an ERASE or BLANK CHECK operation in progress, DQ7 outputs 0; upon either operation's successful completion, DQ7 outputs 1.
- 3. After successful completion of a PROGRAM, ERASE, or BLANK CHECK operation, the device returns to read mode.
- 4. During erase suspend mode, READ operations to addresses within blocks not being erased output memory array data as if in read mode. A protected block is treated the same as a block not being erased. See the Toggle Flowchart for more information.
- 5. During erase suspend mode, DQ6 toggles when addressing a cell within a block being erased. The toggling stops when the program/erase controller has suspended the ERASE operation. See the Toggle Flowchart for more information.



6. When DQ5 is set to 1, a READ/RESET command must be issued before any subsequent command.

Table 14: Operations and Corresponding Bit Settings

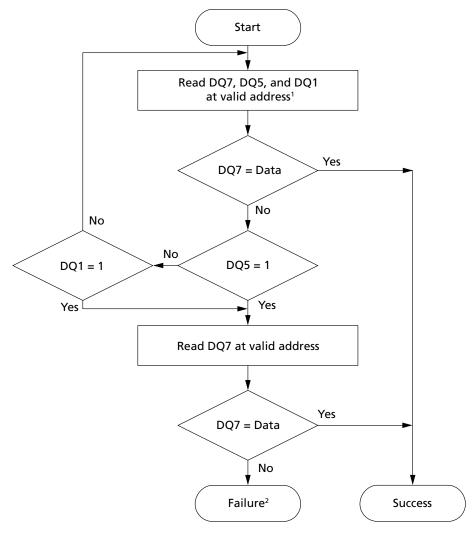
Note 1 applies to entire table

Operation	Address	DQ7	DQ6	DQ5	DQ3	DQ2	DQ1	RY/BY#	Notes
PROGRAM	Any address	DQ7#	Toggle	0	_	_	0	0	2
BLANK CHECK	Any address	1	Toggle	0	_	_	0	0	
CHIP ERASE	Any address	0	Toggle	0	1	Toggle	_	0	
BLOCK ERASE	Erasing block	0	Toggle	0	0	Toggle	_	0	
before time-out	Non-erasing block	0	Toggle	0	0	No toggle	_	0	
BLOCK ERASE	Erasing block	0	Toggle	0	1	Toggle	_	0	
	Non-erasing block	0	Toggle	0	1	No toggle	_	0	
PROGRAM SUSPEND	Programming block			Invalid o	peration			High-Z	
	Nonprogramming Outputs memory array data as if in read mode block								
ERASE	Erasing blk	1	No Toggle	0	_	Toggle	_	High-Z	
SUSPEND	Non-erasing blk	(Outputs mem	ory array	data as if	in read mode	9	High-Z	
PROGRAM during	Erasing block	DQ7#	Toggle	0	_	Toggle	_	0	2
ERASE SUSPEND	Non-erasing block	DQ7#	Toggle	0	_	No Toggle	_	0	2
BUFFERED PROGRAM ABORT	Any address	DQ7#	Toggle	0	_	-	1	High-Z	
PROGRAM Error	Any address	DQ7#	Toggle	1	_	_	_	High-Z	2
ERASE Error	Erase success block	0	Toggle	1	1	No toggle	_	High-Z	
	Erase fail block	0	Toggle	1	1	Toggle	_	High-Z	
BLANK CHECK Er- ror	Any address	1	Toggle	1	1	Toggle	-	High-Z	

- Notes: 1. Unspecified data bits should be ignored.
 - 2. DQ7# for buffer program is related to the last address location loaded.



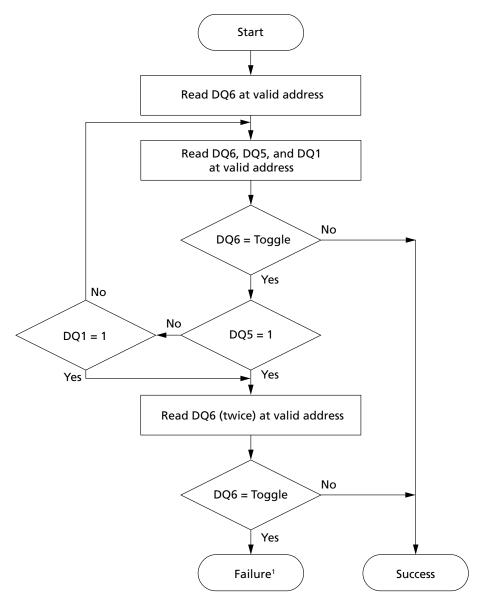
Figure 6: Data Polling Flowchart



- Notes: 1. Valid address is the address being programmed or an address within the block being erased or on which a BLANK CHECK operation has been executed.
 - 2. The data polling process does not support the BLANK CHECK operation. The process represented in the Toggle Bit Flowchart figure can provide information on the BLANK CHECK operation.
 - 3. Failure results: DQ5 = 1 indicates an operation error; DQ1 = 1 indicates a WRITE TO BUF-FER PROGRAM ABORT operation.



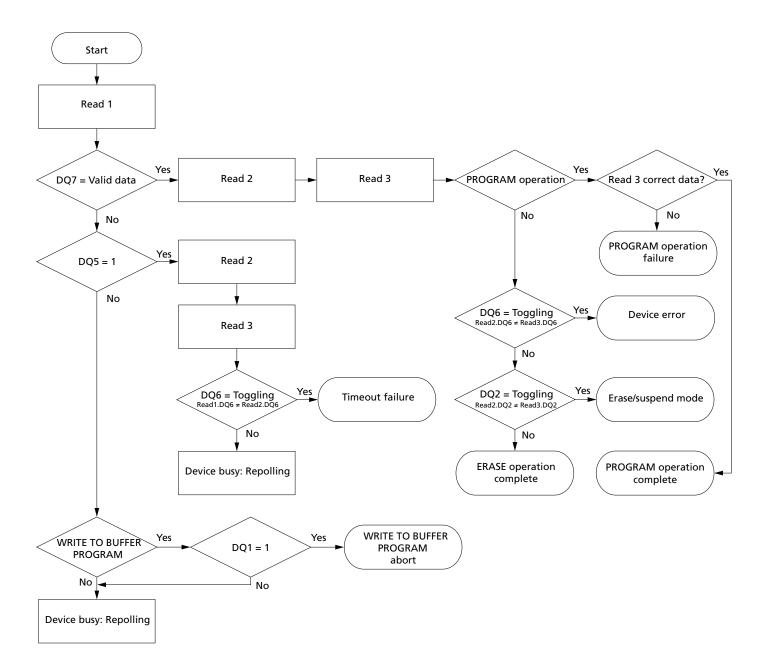
Figure 7: Toggle Bit Flowchart



Note: 1. Failure results: DQ5 = 1 indicates an operation error; DQ1 = 1 indicates a WRITE TO BUFFER PROGRAM ABORT operation.



Figure 8: Status Register Polling Flowchart





Lock Register

Table 15: Lock Register Bit Definitions

Note 1 applies to entire table

Bit	Name	Settings	Description	Notes
DQ2	Password protection mode lock bit	0 = Password protection mode enabled 1 = Password protection mode disabled (Default)	Places the device permanently in password protection mode.	2
DQ1	Nonvolatile protection mode lock bit	0 = Nonvolatile protection mode enabled with pass- word protection mode permanently disabled 1 = Nonvolatile protection mode enabled (Default)	word protection mode permanently disabled. When shipped from the factory, the device will operate in nonvolatile protection mode, and the memory blocks are unprotected.	2
DQ0	Extended memory block protection bit	0 = Protected 1 = Unprotected (Default)	If the device is shipped with the extended memory block unlocked, the block can be protected by setting this bit to 0. The extended memory block protection status can be read in auto select mode by issuing an AUTO SELECT command.	

Notes:

- 1. The lock register is a 16-bit, one-time programmable register. DQ[15:3] are reserved and are set to a default value of 1.
- 2. The password protection mode lock bit and nonvolatile protection mode lock bit cannot both be programmed to 0. Any attempt to program one while the other is programmed causes the operation to abort, and the device returns to read mode. The device is shipped from the factory with the default setting.

Table 16: Block Protection Status

Nonvolatile Protection Bit Lock Bit ¹	Nonvolatile Protection Bit ²	Volatile Protection Bit ³	Block Protection Status	Block Protection Status
1	1	1	00h	Block unprotected; nonvolatile protection bit changeable.
1	1	0	01h	Block protected by volatile protection bit; nonvolatile protection bit changeable.
1	0	1	01h	Block protected by nonvolatile protection bit; nonvolatile protection bit changeable.
1	0	0	01h	Block protected by nonvolatile protection bit and volatile protection bit; nonvolatile protection bit changeable.
0	1	1	00h	Block unprotected; nonvolatile protection bit unchangeable.
0	1	0	01h	Block protected by volatile protection bit; nonvolatile protection bit unchangeable.
0	0	1	01h	Block protected by nonvolatile protection bit; nonvolatile protection bit unchangeable.



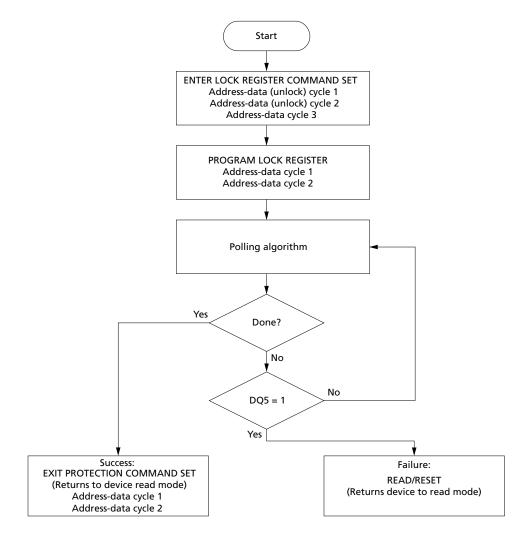
Table 16: Block Protection Status (Continued)

Nonvolatile Protection Bit Lock Bit ¹		Volatile Protection Bit ³	Block Protection Status	Block Protection Status
0	0	0		Block protected by nonvolatile protection bit and volatile protection bit; nonvolatile protection bit unchangeable.

Notes:

- 1. Nonvolatile protection bit lock bit: when cleared to 1, all nonvolatile protection bits are unlocked; when set to 0, all nonvolatile protection bits are locked.
- 2. Block nonvolatile protection bit: when cleared to 1, the block is unprotected; when set to 0, the block is protected.
- 3. Block volatile protection bit: when cleared to 1, the block is unprotected; when set to 0, the block is protected.

Figure 9: Lock Register Program Flowchart





Notes: 1. Each lock register bit can be programmed only once.

2. See the Block Protection Command Definitions table for address-data cycle details.



Standard Command Definitions - Address-Data Cycles

Table 17: Standard Command Definitions - Address-Data Cycles, 8-Bit and 16-Bit

Note 1 applies to entire table

						Addres	ss and	d Data	Cycles					
Command and	Bus	1s	t	2n	d	3r	d	4t	h	51	h	61	th	
Code/Subcode	Size	Α	D	Α	D	Α	D	Α	D	Α	D	Α	D	Notes
READ and AUTO SELEC	T Ope	rations										•	•	
READ/RESET (F0h)	х8	Х	F0											
		AAA	АА	555	55	Х	F0]
	x16	Х	F0											
		555	AA	2AA	55	Х	F0							
READ CFI (98h)	х8	AA	98											
	x16	55												
AUTO SELECT (90h)	х8	AAA	AA	555	55	AAA	90	Note	Note					2, 3, 4
	x16	555		2AA		555		2	2					
BYPASS Operations		'												
UNLOCK BYPASS (20h)	x8	AAA	AA	555	55	AAA	20							
	x16	555		2AA		555								
UNLOCK BYPASS	x8	Х	90	Х	00									
RESET (90h/00h)	x16													
PROGRAM Operations		•												
PROGRAM (A0h)	х8	AAA	AA	555	55	AAA	A0	PA	PD					
	x16	555		2AA		555								
UNLOCK BYPASS	х8	Х	A0	PA	PD									6
PROGRAM (A0h)	x16													
DOUBLE BYTE/WORD	х8	AAA	50	PA2	PD									
PROGRAM (50h)	x16	555												
QUADRUPLE BYTE/	х8	AAA	56	PA4	PD									
WORD PROGRAM (56h)	x16	555												
OCTUPLE BYTE PRO- GRAM (8Bh)	х8	AAA	8B	PA8	PD									5
WRITE TO BUFFER	x8	AAA	АА	555	55	BAd	25	BAd	N	PA	PD			7, 8, 9
PROGRAM (25h)	x16	555		2AA										
ENHANCED WRITE TO BUFFER PROGRAM (33h)	x16	555	AA	2AA	55	BAd	33	PA	PD					7, 9, 10
UNLOCK BYPASS	х8	BAd	25	BAd	N	PA	PD							5
WRITE TO BUFFER PROGRAM (25h)	x16													

32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Standard Command Definitions – Address-Data Cycles

Table 17: Standard Command Definitions - Address-Data Cycles, 8-Bit and 16-Bit (Continued)

Note 1 applies to entire table

	Bus	Address and Data Cycles												
Command and		1st		2nd		3rd		4th		5th		6th		
Code/Subcode	Size	Α	D	Α	D	Α	D	Α	D	Α	D	Α	D	Notes
UNLOCK BYPASS ENHANCED WRITE TO BUFFER PROGRAM (33h)	x16	BAd	33	PA	PD									10
WRITE TO BUFFER	х8	BAd	29											
PROGRAM CONFIRM (29h)	x16													
ENHANCED WRITE	х8	BAd	29											
TO BUFFER PROGRAM CONFIRM (29h)	x16													
BUFFERED PROGRAM	х8	AAA	AA	555	55	AAA	F0							
ABORT and RESET (F0h)	x16	555		2AA	1	555								
PROGRAM SUSPEND	х8	Х	В0		•									
(B0h)	x16													
PROGRAM RESUME	х8	Х	30											
(30h)	x16													
ERASE Operations														
CHIP ERASE (80/10h)	х8	AAA	AA	555	55	AAA	80	AAA	AA	555	55	AAA	10	
	x16	555		2AA		555		555		2AA		555		
UNLOCK BYPASS	x8	Х	80	Х	10									5
CHIP ERASE (80/10h)	x16													
BLOCK ERASE (80/30h)	х8	AAA	AA	555	55	AAA	80	AAA	AA	555	55	BAd	30	11
	x16	555		2AA		555		555		2AA				
UNLOCK BYPASS	х8	Х	80	BAd	30									5
BLOCK ERASE (80/30h)	x16													
ERASE SUSPEND (B0h)	х8	Х	В0											
	x16													
ERASE RESUME (30h)	x8	Х	30											
	x16													
BLANK CHECK Operation	ons							ı		1				
BLANK CHECK	х8	AAA	AA	555	55	BAd	EB	BAd	76	BAd	00	BAd	00	
SETUP (EB/76h)	x16	555		2AA										
BLANK CHECK CONFIRM	х8	BAd	29	BAd	Note									2
and READ (29h)	x16				2									

Notes: 1. A = Address; D = Data; X = "Don't Care;" BAd = Any address in the block; N = Number of bytes to be programmed; PA = Program address; PA2 = Program address with constant AMAX:A0 for x8 or AMAX:A1 for x16, which should be used two times to select adjacent



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Standard Command Definitions - Address-Data Cycles

two bytes/words; PA4 = Program address with constant AMAX:A1 for x8 or AMAX:A2 for x16, which should be used four times to select adjacent four bytes/words; PA8 = Program address with constant AMAX:A2 for x8, which should be used eight times to select adjacent eight bytes; PD = Program data; Gray shading = Not applicable. All values in the table are hexadecimal. Some commands require both a command code and subcode.

- 2. These cells represent READ cycles (versus WRITE cycles for the others).
- 3. AUTO SELECT enables the device to read the manufacturer code, device code, block protection status, and extended memory block protection indicator.
- 4. AUTO SELECT addresses and data are specified in the Electronic Signature table and the Extended Memory Block Protection table.
- 5. For any UNLOCK BYPASS ERASE/PROGRAM command, the first two UNLOCK cycles are unnecessary.
- 6. This command is only for x8 devices.
- 7. BAd must be the same as the address loaded during the WRITE TO BUFFER PROGRAM 3rd and 4th cycles.
- 8. WRITE TO BUFFER PROGRAM operation: maximum cycles = 261 (x8) and 261 (x16). UNLOCK BYPASS WRITE TO BUFFER PROGRAM operation: maximum cycles = 259 (x8), 259 (x16). WRITE TO BUFFER PROGRAM operation: N + 1 = bytes to be programmed; maximum buffer size = 256 bytes (x8) and 512 bytes (x16).
- 9. For x8, A[MAX:7] address pins should remain unchanged while A[6:0] and A-1 pins are used to select a byte within the N + 1 byte page. For x16, A[MAX:8] address pins should remain unchanged while A[7:0] pins are used to select a word within the N+1 word page.
- This command is only for x16 devices. For ENHANCED WRITE TO BUFFER PROGRAM operation, total cycles = 259. For UNLOCK BYPASS ENHANCED WRITE TO BUFFER PROGRAM operation, total cycles = 257.
- 11. BLOCK ERASE address cycles can extend beyond six address-data cycles, depending on the number of blocks to erase.

32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash READ and AUTO SELECT Operations

READ and AUTO SELECT Operations

READ/RESET Command

The READ/RESET (F0h) command returns the device to read mode and resets the errors in the status register. One or three bus WRITE operations can be used to issue the READ/RESET command.

To return the device to read mode, this command can be issued between bus WRITE cycles before the start of a PROGRAM or ERASE operation. If the READ/RESET command is issued during the timeout of a BLOCK ERASE operation, the device requires up to 10µs to abort, during which time no valid data can be read.

This command will not abort an ERASE operation while in erase suspend.

READ CFI Command

The READ CFI (98h) command puts the device in read CFI mode and is only valid when the device is in read array or auto select mode. One bus WRITE cycle is required to issue the command.

Once in read CFI mode, bus READ operations will output data from the CFI memory area (Refer to the Common Flash Interface for details). A READ/RESET command must be issued to return the device to the previous mode (read array or auto select). A second READ/RESET command is required to put the device in read array mode from auto select mode.

AUTO SELECT Command

At power-up or after a hardware reset, the device is in read mode. It can then be put in auto select mode by issuing an AUTO SELECT (90h) command. Auto select mode enables the following device information to be read:

- Electronic signature, which includes manufacturer and device code information as shown in the Electronic Signature table.
- Block protection, which includes the block protection status and extended memory block protection indicator, as shown in the Block Protection table.

Electronic signature or block protection information is read by executing a READ operation with control signals and addresses set, as shown in the Read Electronic Signature table or the Block Protection table, respectively. In addition, this device information can be read or set by issuing an AUTO SELECT command.

Auto select mode can be used by the programming equipment to automatically match a device with the application code to be programmed.

Three consecutive bus WRITE operations are required to issue an AUTO SELECT command. The device remains in auto select mode until a READ/RESET or READ CFI command is issued.

The device cannot enter auto select mode when a PROGRAM or ERASE operation is in progress (RY/BY# LOW). However, auto select mode can be entered if the PROGRAM or ERASE operation has been suspended by issuing a PROGRAM SUSPEND or ERASE SUSPEND command.



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash READ and AUTO SELECT Operations

Auto select mode is exited by performing a reset. The device returns to read mode unless it entered auto select mode after an ERASE SUSPEND or PROGRAM SUSPEND command, in which case it returns to erase or program suspend mode.

Table 18: Read Electronic Signature

Note 1 applies to entire table

	- 1- 1- 1- 1-	entire table				Data Input/Output								
			8-Bit/16-Bit (8-Bit Only		16-Bit Only		
Read Cycle		CE#	OE#	WE#	A[MAX:11]	A[10:4]	А3	A2	A1	A0	A-1	DQ[14:8]	DQ[7:0]	DQ[15:0]
Manufa code	acturer	L	L	Н	Х	L	L	L	L	L	Х	Х	89h	0089h
Device	code 1	L	L	Н	Х	L	L	L	L	Н	Х	Х	7Eh	227Eh
Device	128Mb	L	L	Н	Х	L	Н	Н	Н	L	Х	Х	21h	2221h
code 2	64Mb boot												10h	2210h
	64Mb uniform												0Ch	220Ch
	32Mb boot												1Ah	221Ah
	32Mb uniform												1Dh	221Dh
Device code 3	128Mb uniform	L	L	Н	Х	L	Н	Н	Н	Н	Х	Х	01h	2201h
	64Mb uniform													
	64Mb top													
	32Mb top													
Device code 3	64Mb bottom	L	L	Н	Х	L	Н	Н	Н	Н	Х	Х	00h	2200h
	32Mb bottom													
	32Mb uniform													

Note: 1. $H = Logic level HIGH (V_{IH})$; $L = Logic level LOW (V_{IL})$; X = HIGH or LOW.

32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Bypass Operations

Table 19: Block Protection

Note 1 applies to entire table

						Addre	Data Input/Output						
					8-Bit/16-Bit 0						8-Bit Only		16-Bit Only
Read Cycle		CE#	OE# WE		A[MAX:15]	A[14:11]	A[10:2]	A1	A0	A-1	DQ[14:8]	DQ[7:0]	DQ[15:0]
Extended	M29EWL	L	L	Н	Х	Х	L	Н	Н	Х	Х	89h ²	0089h ²
memory	128Mb											09h ³	0009h ³
Block protection	M29EWH	L	L	Н	Х	Х	L	Н	Н	Х	Х	99h ²	0099h ²
indicator	128Mb											19h ³	0019h ³
(DQ7)	M29EWL	L	L	Н	Х	Х	L	Н	Н	Х	Х	8Ah ²	008Ah ²
	64Mb 32Mb											0Ah ³	000Ah ³
	M29EWH	L	L	Н	Х	Х	L	Н	Н	Х	Х	9Ah ²	009Ah ²
	64Mb 32Mb											1Ah ³	001Ah ³
	M29EWB	L	L	Н	Х	Х	L	Н	Н	Х	Х	8Ah ²	008Ah ²
	64Mb 32Mb											0Ah ³	000Ah ³
	M29EWT	L	L	Н	Х	Х	L	Н	Н	Х	Х	9Ah ²	009Ah ²
	64Mb 32Mb											1Ah ³	001Ah ³
Block protection		L	L	Н	Block base	L	L	Н	L	Х	Х	01h ⁴	0001h ⁴
status					address ⁶							00h ⁵	0000h ⁵

Notes:

- 1. $H = Logic level HIGH (V_{IH}); L = Logic level LOW (V_{IL}); X = HIGH or LOW.$
- 2. Micron-prelocked (permanent).
- 3. Customer-lockable.
- 4. Protected: 01h (in x8 mode) is output on DQ[7:0].
- 5. Unprotected: 00h (in x8 mode) is output on DQ[7:0].
- 6. Block base address for 128Mb device, should be A[MAX:16], while A15 = X.

Bypass Operations

UNLOCK BYPASS Command

The UNLOCK BYPASS (20h) command is used to place the device in unlock bypass mode. Three bus WRITE operations are required to issue the UNLOCK BYPASS command.

When the device enters unlock bypass mode, the two initial UNLOCK cycles required for a standard PROGRAM or ERASE operation are not needed, thus enabling faster total program or erase time.

The UNLOCK BYPASS command is used in conjunction with UNLOCK BYPASS PRO-GRAM or UNLOCK BYPASS ERASE commands to program or erase the device faster than with standard PROGRAM or ERASE commands. When the cycle time to the device



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Program Operations

is long, considerable time savings can be gained by using these commands. When in unlock bypass mode, only the following commands are valid:

- The UNLOCK BYPASS PROGRAM command can be issued to program addresses within the device.
- The UNLOCK BYPASS BLOCK ERASE command can then be issued to erase one or more memory blocks.
- The UNLOCK BYPASS CHIP ERASE command can be issued to erase the whole memory array.
- The UNLOCK BYPASS WRITE TO BUFFER PROGRAM and UNLOCK BYPASS EN-HANCED WRITE TO BUFFER PROGRAM commands can be issued to speed up the programming operation.
- The UNLOCK BYPASS RESET command can be issued to return the device to read mode.

In unlock bypass mode, the device can be read as if in read mode.

In addition to the UNLOCK BYPASS command, when $V_{PP}/WP\#$ is raised to V_{PPH} , the device automatically enters unlock bypass mode. When $V_{PP}/WP\#$ returns to V_{IH} or V_{IL} , the device is no longer in unlock bypass mode and normal operation resumes. The transitions from V_{IH} to V_{PPH} and from V_{PPH} to V_{IH} must be slower than tVHVPP (see the Accelerated Program, Data Polling/Toggle AC Characteristics).

Note: Micron recommends the user enter and exit unlock bypass mode using ENTER UNLOCK BYPASS and UNLOCK BYPASS RESET commands rather than raising $V_{PP}/WP\#$ to V_{PPH} . $V_{PP}/WP\#$ should never be raised to V_{PPH} from any mode except read mode; otherwise, the device may be left in an indeterminate state.

UNLOCK BYPASS RESET Command

The UNLOCK BYPASS RESET (90/00h) command is used to return to read/reset mode from unlock bypass mode. Two bus WRITE operations are required to issue the UNLOCK BYPASS RESET command. The READ/RESET command does not exit from unlock bypass mode.

Program Operations

PROGRAM Command

The PROGRAM (A0h) command can be used to program a value to one address in the memory array. The command requires four bus WRITE operations, and the final WRITE operation latches the address and data in the internal state machine and starts the program/erase controller. After programming has started, bus READ operations output the status register content.

Programming can be suspended and then resumed by issuing a PROGRAM SUSPEND command and a PROGRAM RESUME command, respectively.

If the address falls in a protected block, the PROGRAM command is ignored, and the data remains unchanged. The status register is not read, and no error condition is given.

After the PROGRAM operation has completed, the device returns to read mode, unless an error has occurred. When an error occurs, bus READ operations to the device contin-



ue to output the status register. A READ/RESET command must be issued to reset the error condition and return the device to read mode.

The PROGRAM command cannot change a bit set to 0 back to 1, and an attempt to do so is masked during a PROGRAM operation. Instead, an ERASE command must be used to set all bits in one memory block or in the entire memory from 0 to 1.

The PROGRAM operation is aborted by performing a reset or by powering-down the device. In this case, data integrity cannot be ensured, and it is recommended that the words or bytes that were aborted be reprogrammed.

UNLOCK BYPASS PROGRAM Command

When the device is in unlock bypass mode, the UNLOCK BYPASS PROGRAM (A0h) command can be used to program one address in the memory array. The command requires two bus WRITE operations instead of four required by a standard PROGRAM command; the final WRITE operation latches the address and data and starts the program/erase controller (The standard PROGRAM command requires four bus WRITE operations). The PROGRAM operation using the UNLOCK BYPASS PROGRAM command behaves identically to the PROGRAM operation using the PROGRAM command. The operation cannot be aborted. A bus READ operation to the memory outputs the status register.

DOUBLE BYTE/WORD PROGRAM Command

The DOUBLE BYTE/WORD PROGRAM (50h) command is used to write a page of two adjacent bytes/words in parallel. The two bytes/words must differ only for the address A-1 or A0, respectively. Three bus write cycles are necessary to issue the command: The first bus cycle sets up the command, the second bus cycle latches the address and data of the first byte/word to be programmed, and the third bus cycle latches the address and data of the second byte/word to be programmed and starts the program/erase controller.

Note: The DOUBLE BYTE/WORD PROGRAM command is available only in the 32Mb and 64Mb devices; also only V_{PPL} is to be applied to the $V_{PP}/WP\#$ pin.

QUADRUPLE BYTE/WORD PROGRAM Command

The QUADRUPLE BYTE/WORD PROGRAM (56h) command is used to write a page of four adjacent bytes/words in parallel. The four bytes/words must differ for addresses A0, DQ15/A-1 in x8 mode or for addresses A1, A0 in x16 mode. Five bus write cycles are necessary to issue the command: The first bus cycle sets up the command, the second bus cycle latches the address and data of the first byte/word to be programmed, the third bus cycle latches the address and data of the second byte/word to be programmed, the fourth bus cycle latches the address and data of the third byte/word to be programmed, and the fifth bus cycle latches the address and data of the fourth byte/word to be programmed and starts the program/erase controller.

Note: The QUADRUPLE BYTE/WORD PROGRAM command is available only in the 32Mb and 64Mb devices; also only $V_{\rm PPL}$ is to be applied to the $V_{\rm PP}/WP\#$ pin.



OCTUPLE BYTE PROGRAM Command

The OCTUPLE BYTE PROGRAM (8Bh) command is used to write a page of eight adjacent bytes in parallel. The eight bytes must differ for addresses A1, A0, DQ15/A-1 in x8 mode only.

Nine bus write cycles are necessary to issue the command: The first bus cycle sets up the command, the second bus cycle latches the address and data of the first byte to be programmed, the third bus cycle latches the address and data of the second byte to be programmed, the fourth bus cycle latches the address and data of the third byte to be programmed, the sixth bus cycle latches the address and data of the fifth byte to be programmed, the seventh bus cycle latches the address and data of the sixth byte to be programmed, the eighth bus cycle latches the address and data of the seventh byte to be programmed, and the ninth bus cycle latches the address and data of the eighth byte to be programmed, and starts the program/erase controller.

Note: The OCTUPLE BYTE PROGRAM command is available only in the 32Mb and 64Mb x8 devices; also only V_{PPL} is to be applied to the $V_{PP}/WP\#$ pin.

WRITE TO BUFFER PROGRAM Command

The WRITE TO BUFFER PROGRAM (25h) command makes use of the program buffer to speed up programming and dramatically reduces system programming time compared to the standard non-buffered PROGRAM command. 32Mb through 128Mb devices support a 256-word maximum program buffer.

When issuing a WRITE TO BUFFER PROGRAM command, $V_{PP}/WP\#$ can be held HIGH or raised to V_{PPH} . Also, it can be held LOW if the block is not the lowest or highest block or the top/bottom two blocks, depending on the part number. When V_{PPH} is applied to the $V_{PP}/WP\#$ pin during execution of the command, programming speed increases (see the Accelerated Program, Data Polling/Toggle AC Characteristics section).

The following successive steps are required to issue the WRITE TO BUFFER PROGRAM command:

First, two UNLOCK cycles are issued. Next, a third bus WRITE cycle sets up the WRITE TO BUFFER PROGRAM command. The set-up code can be addressed to any location within the targeted block. Then, a fourth bus WRITE cycle sets up the number of words/bytes to be programmed. Value n is written to the same block address, where n+1 is the number of words/bytes to be programmed. Value n+1 must not exceed the size of the program buffer, or the operation will abort. A fifth cycle loads the first address and data to be programmed. Last, n bus WRITE cycles load the address and data for each word/byte into the program buffer. Addresses must lie within the range from *the start address* +1 to +1 to

Optimum programming performance and lower power usage are achieved by aligning the starting address at the beginning of a 256-word boundary (A[7:0] = 0x000h). Any buffer size smaller than 256 words is allowed within a 256-word boundary, while all addresses used in the operation must lie within the 256-word boundary. In addition, any crossing boundary buffer program will result in a program abort. For a x8 device, maximum buffer size is 256 bytes; for a x16 device, the maximum buffer size is 512 bytes.

To program the content of the program buffer, this command must be followed by a WRITE TO BUFFER PROGRAM CONFIRM command.



If an address is written several times during a WRITE TO BUFFER PROGRAM operation, the address/data counter will be decremented at each data load operation, and the data will be programmed to the last word loaded into the buffer.

Invalid address combinations or the incorrect sequence of bus WRITE cycles will abort the WRITE TO BUFFER PROGRAM command.

The status register bits DQ1, DQ5, DQ6, DQ7 can be used to monitor the device status during a WRITE TO BUFFER PROGRAM operation.

The WRITE TO BUFFER PROGRAM command should not be used to change a bit set to 0 back to 1, and an attempt to do so is masked during the operation. Rather than the WRITE TO BUFFER PROGRAM command, the ERASE command should be used to set memory bits from 0 to 1.

Figure 10: Boundary Condition of Program Buffer Size

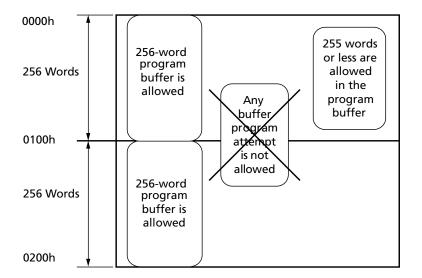
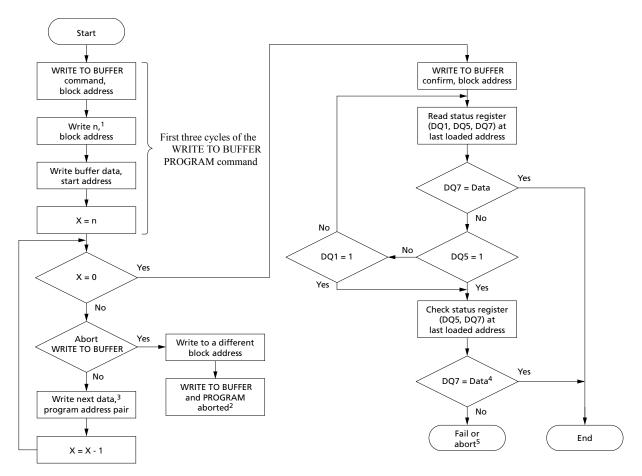




Figure 11: WRITE TO BUFFER PROGRAM Flowchart



Notes

- 1. n + 1 is the number of addresses to be programmed.
- 2. The BUFFERED PROGRAM ABORT and RESET command must be issued to return the device to read mode.
- 3. When the block address is specified, any address in the selected block address space is acceptable. However, when loading program buffer address with data, all addresses must fall within the selected program buffer page.
- 4. DQ7 must be checked because DQ5 and DQ7 may change simultaneously.
- 5. If this flowchart location is reached because DQ5 = 1, then the WRITE TO BUFFER PRO-GRAM command failed. If this flowchart location is reached because DQ1 = 1, then the WRITE TO BUFFER PROGRAM command aborted. In both cases, the appropriate RESET command must be issued to return the device to read mode: A RESET command if the operation failed; a WRITE TO BUFFER PROGRAM ABORT AND RESET command if the operation aborted.
- 6. See the Standard Command Definitions Address-Data Cycles, 8-Bit and 16-Bit table for details about the WRITE TO BUFFER PROGRAM command sequence.

UNLOCK BYPASS WRITE TO BUFFER PROGRAM Command

When the device is in unlock bypass mode, the UNLOCK BYPASS WRITE TO BUFFER (25h) command can be used to program the device in fast program mode. The com-



mand requires two bus WRITE operations fewer than the standard WRITE TO BUFFER PROGRAM command.

The UNLOCK BYPASS WRITE TO BUFFER PROGRAM command behaves the same way as the WRITE TO BUFFER PROGRAM command: the operation cannot be aborted, and a bus READ operation to the memory outputs the status register.

The WRITE TO BUFFER PROGRAM CONFIRM command is used to confirm an UNLOCK BYPASS WRITE TO BUFFER PROGRAM command and to program the n+1 words/bytes loaded in the program buffer by this command.

ENHANCED WRITE TO BUFFER PROGRAM Command

The ENHANCED WRITE TO BUFFER PROGRAM (33h) command enables loading 256 words into the writer buffer to reduce system programming time. Each write buffer has the same A[22:8] addresses. Execution speed is identical to the 256-word WRITE TO BUFFER program speed (See the Program/Erase Characteristics table for details).

When issuing this command, the $V_{PP}/WP\#$ pin can be held HIGH or raised to V_{PPH} (programming acceleration).

Note: The ENHANCED WRITE TO BUFFER PROGRAM command is available only in the 128Mb x16 device.

The following successive steps are required to issue the command: Two unlock cycles begin the command, followed by a third bus write cycle that sets up the command with setup code that can be addressed to any location within the targeted block. The fourth bus write cycle loads the first address and data to be programmed. There are a total of 256 address and data loading cycles.

The command must be followed by an ENHANCED WRITE TO BUFFER PROGRAM CONFIRM command to program the buffer content, which confirm cycle ends the command.

Note that address/data cycles must be loaded in an increasing address order (A[7:0] from 00h to FFh) that includes all 256 words. Invalid address combinations or the correct sequence of bus write cycles will result in an abort.

Status register bits DQ1, DQ5, DQ6, and DQ7 enable monitoring the device status during operation. A 12V external supply can be used to improve programming efficiency. The ENHANCED WRITE TO BUFFER PROGRAM command should not be used to change a bit set to 0 back to 1. Any attempt to do so is masked during the operation. The ERASE command should be used to set memory bits from 0 to 1.

UNLOCK BYPASS ENHANCED WRITE TO BUFFER PROGRAM Command

The UNLOCK BYPASS ENHANCED WRITE TO BUFFER PROGRAM (33h) command can be used to program the memory in fast program mode. The command requires two address/data loading cycles less than the regular ENHANCED WRITE TO BUFFER PROGRAM command. This command behaves identically to the ENHANCED WRITE TO BUFFER PROGRAM command. The operation cannot be aborted and a bus read operation to the memory outputs the status register. This command is confirmed by the ENHANCED WRITE TO BUFFER PROGRAM CONFIRM command, which programs the 256 words loaded in the buffer.



WRITE TO BUFFER PROGRAM CONFIRM Command

The WRITE TO BUFFER PROGRAM CONFIRM (29h) command is used to confirm a WRITE TO BUFFER PROGRAM command and to program the n+1 words/bytes loaded in the program buffer by this command.

ENHANCED WRITE TO BUFFER PROGRAM CONFIRM Command

The ENHANCED WRITE TO BUFFER PROGRAM CONFIRM (29h) command is used to confirm an ENHANCED WRITE TO BUFFER PROGRAM command and to program the 256 words loaded in the buffer.

BUFFERED PROGRAM ABORT AND RESET Command

A BUFFERED PROGRAM ABORT AND RESET (F0h) command must be issued to reset the device to read mode when the BUFFER PROGRAM operation is aborted. The buffer programming sequence can be aborted in the following ways:

- Load a value that is greater than the page buffer size during the number of locations to program in the WRITE TO BUFFER PROGRAM command.
- Write to an address in a different block than the one specified during the WRITE BUF-FER LOAD command.
- Write an address/data pair to a different write buffer page than the one selected by the starting address during the program buffer data loading stage of the operation.
- Write data other than the CONFIRM command after the specified number of data load cycles.

The abort condition is indicated by DQ1 = 1, DQ7 = DQ7# (for the last address location loaded), DQ6 = toggle, and DQ5 = 0 (all of which are status register bits). A BUFFERED PROGRAM ABORT and RESET command sequence must be written to reset the device for the next operation.

Note: The full three-cycle BUFFERED PROGRAM ABORT and RESET command sequence is required when using buffer programming features in unlock bypass mode.

PROGRAM SUSPEND Command

The PROGRAM SUSPEND (B0h) command can be used to interrupt a program operation so that data can be read from any block. When the PROGRAM SUSPEND command is issued during a program operation, the device suspends the operation within the program suspend latency time and updates the status register bits.

After the program operation has been suspended, data can be read from any address. However, data is invalid when read from an address where a program operation has been suspended.

The PROGRAM SUSPEND command may also be issued during a PROGRAM operation while an erase is suspended. In this case, data may be read from any address not in erase suspend or program suspend mode. To read from the extended memory block area (one-time programmable area), the ENTER/EXIT EXTENDED MEMORY BLOCK command sequences must be issued.

The system may also issue the AUTO SELECT command sequence when the device is in program suspend mode. The system can read as many auto select codes as required.



When the device exits auto select mode, the device reverts to program suspend mode and is ready for another valid operation.

The PROGRAM SUSPEND operation is aborted by performing a device reset or powerdown. In this case, data integrity cannot be ensured, and it is recommended that the words or bytes that were aborted be reprogrammed.

PROGRAM RESUME Command

The PROGRAM RESUME (30h) command must be issued to exit a program suspend mode and resume a PROGRAM operation. The controller can use DQ7 or DQ6 status bits to determine the status of the PROGRAM operation. After a PROGRAM RESUME command is issued, subsequent PROGRAM RESUME commands are ignored. Another PROGRAM SUSPEND command can be issued after the device has resumed programming.

Erase Operations

CHIP ERASE Command

The CHIP ERASE (80/10h) command erases the entire chip. Six bus WRITE operations are required to issue the command and start the program/erase controller.

Protected blocks are not erased. If all blocks are protected, the CHIP ERASE operation appears to start, but will terminate within approximately100µs, leaving the data unchanged. No error is reported when protected blocks are not erased.

During the CHIP ERASE operation, the device ignores all other commands, including ERASE SUSPEND. It is not possible to abort the operation. All bus READ operations during CHIP ERASE output the status register on the data I/Os. See the Status Register section for more details.

After the CHIP ERASE operation completes, the device returns to read mode, unless an error has occurred. If an error occurs, the device will continue to output the status register. A READ/RESET command must be issued to reset the error condition and return to read mode.

The CHIP ERASE command sets all of the bits in unprotected blocks of the device to 1. All previous data is lost.

The operation is aborted by performing a reset or by powering-down the device. In this case, data integrity cannot be ensured, and it is recommended that the entire chip be erased again.

UNLOCK BYPASS CHIP ERASE Command

When the device is in unlock bypass mode, the UNLOCK BYPASS CHIP ERASE (80/10h) command can be used to erase all memory blocks at one time. The command requires only two bus WRITE operations instead of six using the standard CHIP ERASE command. The final bus WRITE operation starts the program/erase controller.

The UNLOCK BYPASS CHIP ERASE command behaves the same way as the CHIP ERASE command: the operation cannot be aborted, and a bus READ operation to the memory outputs the status register.



BLOCK ERASE Command

The BLOCK ERASE (80/30h) command erases a list of one or more blocks. It sets all of the bits in the unprotected selected blocks to 1. All previous data in the selected blocks is lost.

Six bus WRITE operations are required to select the first block in the list. Each additional block in the list can be selected by repeating the sixth bus WRITE operation using the address of the additional block. After the command sequence is written, a block erase timeout occurs. During the timeout period, additional block addresses and BLOCK ERASE commands can be written. After the program/erase controller has started, it is not possible to select any more blocks. Each additional block must therefore be selected within the timeout period of the last block. The timeout timer restarts when an additional block is selected. After the sixth bus WRITE operation, a bus READ operation outputs the status register. See the WE#-Controlled Program waveforms for details on how to identify if the program/erase controller has started the BLOCK ERASE operation.

After the BLOCK ERASE operation completes, the device returns to read mode, unless an error has occurred. If an error occurs, bus READ operations will continue to output the status register. A READ/RESET command must be issued to reset the error condition and return to read mode.

If any selected blocks are protected, they are ignored, and all the other selected blocks are erased. If all of the selected blocks are protected, the BLOCK ERASE operation appears to start, but will terminate within approximately100µs, leaving the data unchanged. No error condition is given when protected blocks are not erased.

During the BLOCK ERASE operation, the device ignores all commands except the ERASE SUSPEND command and the READ/RESET command, which is accepted only during the timeout period. The operation is aborted by performing a reset or powering-down the device. In this case, data integrity cannot be ensured, and it is recommended that the aborted blocks be erased again.

UNLOCK BYPASS BLOCK ERASE Command

When the device is in unlock bypass mode, the UNLOCK BYPASS BLOCK ERASE (80/30h) command can be used to erase one or more memory blocks at a time. The command requires two bus WRITE operations instead of six using the standard BLOCK ERASE command. The final bus WRITE operation latches the address of the block and starts the program/erase controller.

To erase multiple blocks (after the first two bus WRITE operations have selected the first block in the list), each additional block in the list can be selected by repeating the second bus WRITE operation using the address of the additional block.

The UNLOCK BYPASS BLOCK ERASE command behaves the same way as the BLOCK ERASE command: the operation cannot be aborted, and a bus READ operation to the memory outputs the status register. See the BLOCK ERASE Command section for details.

ERASE SUSPEND Command

The ERASE SUSPEND (B0h) command temporarily suspends a BLOCK ERASE operation. One bus WRITE operation is required to issue the command. The block address is "Don't Care."



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash BLANK CHECK Operation

The program/erase controller suspends the ERASE operation within the erase suspend latency time of the ERASE SUSPEND command being issued. However, when the ERASE SUSPEND command is written during the block erase timeout, the device immediately terminates the timeout period and suspends the ERASE operation. After the program/erase controller has stopped, the device operates in read mode, and the erase is suspended.

During an ERASE SUSPEND operation, it is possible to read and execute PROGRAM operations or WRITE TO BUFFER PROGRAM operations in blocks that are not suspended. Both READ and PROGRAM operations behave normally on these blocks. Reading from blocks that are suspended will output the status register. If any attempt is made to program in a protected block or in the suspended block, the PROGRAM command is ignored, and the data remains unchanged. In this case, the status register is not read, and no error condition is given.

It is also possible to issue AUTO SELECT, READ CFI, and UNLOCK BYPASS commands during an ERASE SUSPEND operation. The READ/RESET command must be issued to return the device to read array mode before the RESUME command will be accepted.

During an ERASE SUSPEND operation, a bus READ operation to the extended memory block will output the extended memory block data. After the device enters extended memory block mode, the EXIT EXTENDED MEMORY BLOCK command must be issued before the ERASE operation can be resumed.

An ERASE SUSPEND command is ignored if it is written during a CHIP ERASE operation.

If the ERASE SUSPEND operation is aborted by performing a device reset or powerdown, data integrity cannot be ensured, and it is recommended that the suspended blocks be erased again.

ERASE RESUME Command

The ERASE RESUME (30h) command restarts the program/erase controller after an ERASE SUSPEND operation.

The device must be in read array mode before the RESUME command will be accepted. An erase can be suspended and resumed more than once.

BLANK CHECK Operation

BLANK CHECK Commands

Two commands are required to execute a BLANK CHECK operation: BLANK CHECK SETUP (EB/76h) and BLANK CHECK CONFIRM AND READ (29h).

The BLANK CHECK operation determines whether a specified block is blank (that is, completely erased). It can also be used to determine whether a previous ERASE operation was successful, including ERASE operations that might have been interrupted by power loss.

The BLANK CHECK operation checks for cells that are programmed or over-erased. If it finds any, it returns a failure status, indicating that the block is not blank. If it returns a passing status, the block is guaranteed blank (all 1s) and is ready to program.



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash BLANK CHECK Operation

Before executing, the ERASE operation initiates a BLANK CHECK operation, and if the target block is blank, the ERASE operation is skipped, benefitting overall cycle performance; otherwise, the ERASE operation continues.

The BLANK CHECK operation can occur in only one block at a time, and during its execution, reading the status register is the only other operation allowed. Reading from any address in the device enables reading the status register to monitor blank check progress or errors. Operations such as READ (array data), PROGRAM, ERASE, and any suspended operation are not allowed.

After the BLANK CHECK operation has completed, the device returns to read mode unless an error has occurred. When an error occurs, the device continues to output status register data. A READ/RESET command must be issued to reset the error condition and return the device to read mode.



Block Protection Command Definitions – Address-Data Cycles

Table 20: Block Protection Command Definitions - Address-Data Cycles, 8-Bit and 16-Bit

Notes 1 and 2 apply to entire table

		Address and Data Cycles											
Command and	Bus	•	1st	21	nd	3rd		4th			r	rth	
Code/Subcode	Size	Α	D	Α	D	Α	D	Α	D][Α	D	Notes
LOCK REGISTER Command	ds								•			•	
ENTER LOCK REGISTER	х8	AAA	AA	555	55	AAA	40						3
COMMAND SET (40h)	x16	555	AA	2AA	55	555							
PROGRAM LOCK REGISTER	x8	Х	A0	Х	Data								5
(A0h)	x16												
READ LOCK REGISTER	x8	Х	Data		<u>'</u>								4, 5, 6
	x16												
PASSWORD PROTECTION (Comma	nds	'	l									
ENTER PASSWORD	x8	AAA	AA	555	55	AAA	60						3
PROTECTION COMMAND SET (60h)	x16	555	AA	2AA	55	555							
PROGRAM PASSWORD	х8	Х	A0	PWAn	PWDn								7
(A0h)	x16												
READ PASSWORD	х8	00	PWD0	01	PWD1	02	PWD2	03	PWD3		07	PWD7	4, 6, 8,
	x16	00	PWD0	01	PWD1	02	PWD2	03	PWD3				9
UNLOCK PASSWORD (25h/	х8	00	25	00	03	00	PWD0	01	PWD1		00	29	8, 10
03h)	x16												
NONVOLATILE PROTECTIO	N Com	mands							•			•	•
ENTER NONVOLATILE	х8	AAA	AA	555	55	AAA	C0						3
PROTECTION COMMAND SET (C0h)	x16	555	AA	2AA	55	555							
PROGRAM NONVOLATILE	х8	Х	A0	BAd	00								11
PROTECTION BIT (A0h)	x16												
READ NONVOLATILE	х8	BAd	READ(0)										4, 6,
PROTECTION BIT STATUS	x16												11
CLEAR ALL NONVOLATILE	х8	Х	80	00	30								12
PROTECTION BITS (80/30h)	x16												
NONVOLATILE PROTECTIO	N BIT L	оск ві	T Comma	ands	'								
ENTER NONVOLATILE	х8	AAA	AA	555	55	AAA	50						3
PROTECTION BIT LOCK BIT COMMAND SET (50h)	x16	555	AA	2AA	55	555							
PROGRAM NONVOLATILE	х8	Х	A0	Х	00								11
PROTECTION BIT LOCK BIT (A0h)	x16												



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash **Block Protection Command Definitions – Address-Data Cycles**

Table 20: Block Protection Command Definitions - Address-Data Cycles, 8-Bit and 16-Bit (Continued)

Notes 1 and 2 apply to entire table

			Address and Data Cycles										
Command and	Bus		1st	2r	nd	31	rd	4	th		<i>n</i> th		
Code/Subcode	Size	Α	D	Α	D	Α	D	Α	D]	A	D	Notes
READ NONVOLATILE	х8	Х	READ(0)									•	4, 6,
PROTECTION BIT LOCK BIT	x16												11
STATUS													
VOLATILE PROTECTION Co	mman	ds											
ENTER VOLATILE	x8	AAA	AA	555	55	AAA	E0						3
PROTECTION COMMAND	x16	555	AA	2AA	55	555							
SET (E0h)													
PROGRAM VOLATILE	х8	Х	A0	BAd	00								11
PROTECTION BIT (A0h)	x16												
READ VOLATILE	x8	BAd	READ(0)										4, 6
PROTECTION BIT STATUS	x16												
CLEAR VOLATILE	х8	Х	A0	BAd	01								11
PROTECTION BIT (A0h)	x16												
EXTENDED MEMORY BLO	CK Com	mands	5			'							
ENTER EXTENDED	х8	AAA	AA	555	55	AAA	88						3
MEMORY BLOCK (88h)	x16	555	AA	2AA	55	555							
EXIT EXTENDED	х8	AAA	AA	555	55	AAA	90	Х	00				
MEMORY BLOCK (90/00h)	x16	555	AA	2AA	55	555							
EXIT PROTECTION Comma	nds							•	,	,			•
EXIT PROTECTION	х8	Х	90	Х	00								3
COMMAND SET (90/00h)	x16												

- Notes: 1. Key: A = Address and D = Data; X = "Don't Care;" BAd = any address in the block; PWDn = password bytes 0 to 7; PWAn = password address, n = 0 to 7; Gray = not applicable. All values in the table are hexadecimal.
 - 2. DQ[15:8] are "Don't Care" during UNLOCK and COMMAND cycles. A[MAX:16] are "Don't Care" during UNLOCK and COMMAND cycles, unless an address is required.
 - 3. The ENTER command sequence must be issued prior to any operation. It disables READ and WRITE operations from and to block 0. READ and WRITE operations from and to any other block are allowed. Also, when an ENTER COMMAND SET command is issued, an EXIT PROTECTION COMMAND SET command must be issued to return the device to READ mode.
 - 4. READ REGISTER/PASSWORD commands have no command code; CE# and OE# are driven LOW and data is read according to a specified address.
 - 5. Data = Lock register content.
 - 6. All address cycles shown for this command are READ cycles.
 - 7. Only one portion of the password can be programmed or read by each PROGRAM PASS-WORD command.
 - 8. Each portion of the password can be entered or read in any order as long as the entire 64-bit password is entered or read.



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Block Protection Command Definitions – Address-Data Cycles

- 9. For the x8 READ PASSWORD command, the nth (and final) address cycle equals the 8th address cycle. From the 5th to the 8th address cycle, the values for each address and data pair continue the pattern shown in the table as follows: for x8, address and data = 04 and PWD4; 05 and PWD5; 06 and PWD6; 07 and PWD7.
- 10. For the x8 UNLOCK PASSWORD command, the *n*th (and final) address cycle equals the 11th address cycle. From the 5th to the 10th address cycle, the values for each address and data pair continue the pattern shown in the table as follows: address and data = 02 and PWD2; 03 and PWD3; 04 and PWD4; 05 and PWD5; 06 and PWD6; 07 and PWD7.
 - For the x16 UNLOCK PASSWORD command, the nth (and final) address cycle equals the 7th address cycle. For the 5th and 6th address cycles, the values for the address and data pair continue the pattern shown in the table as follows: address and data = 02 and PWD2; 03 and PWD3.
- 11. Both nonvolatile and volatile protection bit settings are as follows: Protected state = 00; Unprotected state = 01.
- 12. The CLEAR ALL NONVOLATILE PROTECTION BITS command programs all nonvolatile protection bits before erasure. This prevents over-erasure of previously cleared nonvolatile protection bits.



Protection Operations

Blocks can be protected individually against accidental PROGRAM, ERASE, or READ operations on both 8-bit and 16-bit configurations. The block protection scheme is shown in the Software Protection Scheme figure.

Memory block and extended memory block protection is configured through the lock register (see Lock Register section).

LOCK REGISTER Commands

After the ENTER LOCK REGISTER COMMAND SET (40h) command has been issued, all bus READ or PROGRAM operations can be issued to the lock register.

The PROGRAM LOCK REGISTER (A0h) command allows the lock register to be configured. The programmed data can then be checked with a READ LOCK REGISTER command by driving CE# and OE# LOW with the appropriate address data on the address bus.

PASSWORD PROTECTION Commands

After the ENTER PASSWORD PROTECTION COMMAND SET (60h) command has been issued, the commands related to password protection mode can be issued to the device.

The PROGRAM PASSWORD (A0h) command is used to program the 64-bit password used in the password protection mode. To program the 64-bit password, the complete command sequence must be entered eight times at eight consecutive addresses selected by A[1:0] plus DQ15/A-1 in 8-bit mode, or four times at four consecutive addresses selected by A[1:0] in 16-bit mode. By default, all password bits are set to 1. The password can be checked by issuing a READ PASSWORD command.

The READ PASSWORD command is used to verify the password used in password protection mode. To verify the 64-bit password, the complete command sequence must be entered eight times at eight consecutive addresses selected by A[1:0] plus DQ15/A-1 in 8-bit mode, or four times at four consecutive addresses selected by A[1:0] in 16-bit mode. If the password mode lock bit is programmed and the user attempts to read the password, the device will output FFh onto the I/O data bus.

The UNLOCK PASSWORD (25/03h) command is used to clear the nonvolatile protection bit lock bit, allowing the nonvolatile protection bits to be modified. The UNLOCK PASSWORD command must be issued, along with the correct password, and requires a 1µs delay between successive UNLOCK PASSWORD commands in order to prevent hackers from cracking the password by trying all possible 64-bit combinations. If this delay does not occur, the latest command will be ignored. Approximately 1µs is required for unlocking the device after the valid 64-bit password has been provided.

NONVOLATILE PROTECTION Commands

After the ENTER NONVOLATILE PROTECTION COMMAND SET (C0h) command has been issued, the commands related to nonvolatile protection mode can be issued to the device.

A block can be protected from program or erase by issuing a PROGRAM NONVOLATILE PROTECTION BIT (A0h) command, along with the block address. This command sets the nonvolatile protection bit to 0 for a given block.

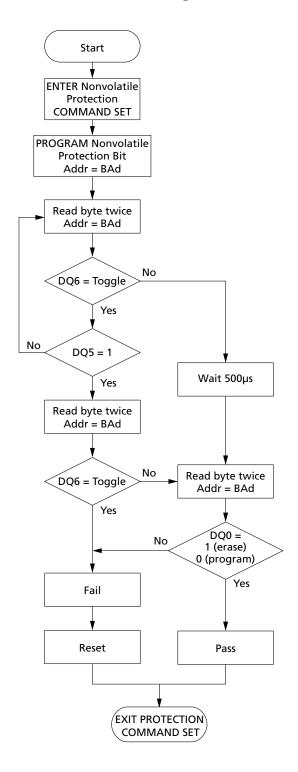


The status of a nonvolatile protection bit for a given block or group of blocks can be read by issuing a READ NONVOLATILE MODIFY PROTECTION BIT command, along with the block address.

The nonvolatile protection bits are erased simultaneously by issuing a CLEAR ALL NONVOLATILE PROTECTION BITS (80/30h) command. No specific block address is required. If the nonvolatile protection bit lock bit is set to 0, the command fails.



Figure 12: Program/Erase Nonvolatile Protection Bit Algorithm



NONVOLATILE PROTECTION BIT LOCK BIT Commands

After the ENTER NONVOLATILE PROTECTION BIT LOCK BIT COMMAND SET (50h) command has been issued, the commands that allow the nonvolatile protection bit lock bit to be set can be issued to the device.

The PROGRAM NONVOLATILE PROTECTION BIT LOCK BIT (A0h) command is used to set the nonvolatile protection bit lock bit to 0, thus locking the nonvolatile protection bits and preventing them from being modified.

The READ NONVOLATILE PROTECTION BIT LOCK BIT STATUS command is used to read the status of the nonvolatile protection bit lock bit.

VOLATILE PROTECTION Commands

After the ENTER VOLATILE PROTECTION COMMAND SET (E0h) command has been issued, commands related to the volatile protection mode can be issued to the device.

The PROGRAM VOLATILE PROTECTION BIT (A0h) command individually sets a volatile protection bit to 0 for a given block. If the nonvolatile protection bit for the same block is set, the block is locked regardless of the value of the volatile protection bit. (See the Block Protection Status table.)

The status of a volatile protection bit for a given block can be read by issuing a READ VOLATILE PROTECTION BIT STATUS command along with the block address.

The CLEAR VOLATILE PROTECTION BIT (A0h) command individually clears (sets to 1) the volatile protection bit for a given block. If the nonvolatile protection bit for the same block is set, the block is locked regardless of the value of the volatile protection bit. (See the Block Protection Status table.)

EXTENDED MEMORY BLOCK Commands

The device has one extra 128-word extended memory block that can be accessed only by the ENTER EXTENDED MEMORY BLOCK (88h) command. The extended memory block is 128 words (x16) or 256 bytes (x8). It is used as a security block to provide a permanent 128-bit security identification number or to store additional information. The device can be shipped with the extended memory block prelocked permanently by Micron, including the 128-bit security identification number. Or, the device can be shipped with the extended memory block unlocked, enabling customers to permanently program and lock it. (See Lock Register, the AUTO SELECT command, and the Block Protection table.)

Table 21: Extended Memory Block Address and Data

		Address		Da	nta
x8 x16 Micron pre			Micron prelocked	Customer	· Lockable
	000000h-00000Fh	000000h-000007h	Secure ID number	Determined by customer	Secure ID number
	000010h-0000FFh	000008h-00007Fh	Protected and unavailable		Determined by customer

After the ENTER EXTENDED MEMORY BLOCK command has been issued, the device enters the extended memory block mode. All bus READ or PROGRAM operations are conducted on the extended memory block, and the extended memory block is ad-



dressed using the addresses occupied by block 0 in the other operating modes (see the Memory Map table).

In extended memory block mode, ERASE, CHIP ERASE, ERASE SUSPEND, and ERASE RESUME commands are not allowed. The extended memory block cannot be erased, and each bit of the extended memory block can only be programmed once.

The extended memory block is protected from further modification by programming lock register bit 0. Once invoked, this protection cannot be undone.

The device remains in extended memory block mode until the EXIT EXTENDED MEMORY BLOCK (90/00h) command is issued, which returns the device to read mode, or until power is removed from the device. After a power-up sequence or hardware reset, the device will revert to reading memory blocks in the main array.

EXIT PROTECTION Command

The EXIT PROTECTION COMMAND SET (90/00h) command is used to exit the lock register, password protection, nonvolatile protection, volatile protection, and nonvolatile protection bit lock bit command set modes and return the device to read mode.

32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Device Protection

Device Protection

Hardware Protection

The $V_{PP}/WP\#$ function provides a hardware method of protecting either the highest/lowest block or the top/bottom two blocks. When $V_{PP}/WP\#$ is LOW, PROGRAM and ERASE operations on either of these block options is ignored to provide protection. When $V_{PP}/WP\#$ is HIGH, the device reverts to the previous protection status for the highest/lowest block or top/bottom two blocks. PROGRAM and ERASE operations can modify the data in either of these block options unless block protection is enabled.

Note: Micron highly recommends driving $V_{PP}/WP\#$ HIGH or LOW. If a system needs to float the $V_{PP}/WP\#$ pin, without a pull-up/pull-down resistor and no capacitor, then an internal pull-up resistor is enabled.

Table 22: V_{PP}/WP# Functions

V _{PP} /WP# Settings	Function
V_{IL}	Highest/lowest block or the top/bottom two blocks are protected.
V _{IH}	Highest/lowest block or the top/bottom two blocks are unprotected unless software protection is activated.

Software Protection

Four software protection modes are available:

- Volatile protection
- Nonvolatile protection
- Password protection
- · Password access

The device is shipped with all blocks unprotected. On first use, the device defaults to the nonvolatile protection mode but can be activated in either the nonvolatile protection or password protection mode.

The desired protection mode is activated by setting either the nonvolatile protection mode lock bit or the password protection mode lock bit of the lock register (see the Lock Register section). Both bits are one-time-programmable and nonvolatile; therefore, after the protection mode has been activated, it cannot be changed, and the device is set permanently to operate in the selected protection mode. It is recommended that the desired software protection mode be activated when first programming the device.

For the lowest and highest blocks or for the top/bottom two blocks, a higher level of block protection can be achieved by locking the blocks using nonvolatile protection mode and holding V_{PP} /WP# LOW.

Blocks with volatile protection and nonvolatile protection can coexist within the memory array. If the user attempts to program or erase a protected block, the device ignores the command and returns to read mode.

The block protection status can be read by performing a read electronic signature or by issuing an AUTO SELECT command (see the Block Protection table).



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Device Protection

Refer to the Block Protection Status table and the Software Protection Scheme figure for details on the block protection scheme. Refer to the Protection Operations section for a description of the command sets.

Volatile Protection Mode

Volatile protection enables the software application to protect blocks against inadvertent change and can be disabled when changes are needed. Volatile protection bits are unique for each block and can be individually modified. Volatile protection bits control the protection scheme only for unprotected blocks whose nonvolatile protection bits are cleared to 1. Issuing a PROGRAM VOLATILE PROTECTION BIT or CLEAR VOLATILE PROTECTION BIT command sets to 0 or clears to 1 the volatile protection bits and places the associated blocks in the protected (0) or unprotected (1) state, respectively. The volatile protection bit can be set or cleared as often as needed.

When the device is first shipped, or after a power-up or hardware reset, the volatile protection bits default to 1 (unprotected).

Nonvolatile Protection Mode

A nonvolatile protection bit is assigned to each block. Each of these bits can be set for protection individually by issuing a PROGRAM NONVOLATILE PROTECTION BIT command. Also, each device has one global volatile bit called the nonvolatile protection bit lock bit; it can be set to protect all nonvolatile protection bits at once. This global bit must be set to 0 only after all nonvolatile protection bits are configured to the desired settings. When set to 0, the nonvolatile protection bit lock bit prevents changes to the state of the nonvolatile protection bits. When cleared to 1, the nonvolatile protection bits can be set and cleared using the PROGRAM NONVOLATILE PROTECTION BIT and CLEAR ALL NONVOLATILE PROTECTION BITS commands, respectively.

No software command unlocks the nonvolatile protection bit lock bit unless the device is in password protection mode; in nonvolatile protection mode, the nonvolatile protection bit lock bit can be cleared only by taking the device through a hardware reset or power-up.

Nonvolatile protection bits cannot be cleared individually; they must be cleared all at once using a CLEAR ALL NONVOLATILE PROTECTION BITS command. They will remain set through a hardware reset or a power-down/power-up sequence.

If one of the nonvolatile protection bits needs to be cleared (unprotected), additional steps are required: First, the nonvolatile protection bit lock bit must be cleared to 1, using either a power-cycle or hardware reset. Then, the nonvolatile protection bits can be changed to reflect the desired settings. Finally, the nonvolatile protection bit lock bit must be set to 0 to lock the nonvolatile protection bits. The device now will operate normally.

To achieve the best protection, the PROGRAM NONVOLATILE PROTECTION LOCK BIT command should be executed early in the boot code, and the boot code should be protected by holding $V_{\rm PP}/WP\#$ LOW.

Nonvolatile protection bits and volatile protection bits have the same function when $V_{PP}/WP\#$ is HIGH or when $V_{PP}/WP\#$ is at the voltage for program acceleration (V_{PPH}).

32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Device Protection

Password Protection Mode

The password protection mode provides a higher level of security than the nonvolatile protection mode by requiring a 64-bit password to unlock the nonvolatile protection bit lock bit. In addition to this password requirement, the nonvolatile protection bit lock bit is set to 0 after power-up and reset to maintain the device in password protection mode.

Executing the UNLOCK PASSWORD command by entering the correct password clears the nonvolatile protection bit lock bit, enabling the block nonvolatile protection bits to be modified. If the password provided is incorrect, the nonvolatile protection bit lock bit remains locked, and the state of the nonvolatile protection bits cannot be modified.

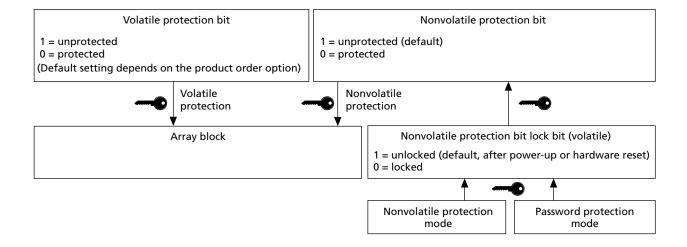
To place the device in password protection mode, the following two steps are required: First, before activating the password protection mode, a 64-bit password must be set and the setting verified. Password verification is allowed only before the password protection mode is activated. Next, password protection mode is activated by programming the password protection mode lock bit to 0. This operation is irreversible. After the bit is programmed, it cannot be erased, the device remains permanently in password protection mode, and the 64-bit password can be neither retrieved nor reprogrammed. In addition, all commands to the address where the password is stored are disabled.

Note: There is no means to verify the password after password protection mode is enabled. If the password is lost after enabling the password protection mode, there is no way to clear the nonvolatile protection bit lock bit.

Password Access

Password access is a security enhancement that protects information stored in the main array blocks by preventing content alteration or reads until a valid 64-bit password is received. Password access may be combined with nonvolatile and/or volatile protection to create a multi-tiered solution. Contact your Micron sales representative for further details.

Figure 13: Software Protection Scheme





32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Device Protection

Notes:

- 1. Volatile protection bits are programmed and cleared individually. Nonvolatile protection bits are programmed individually and cleared collectively.
- 2. Once programmed to 0, the nonvolatile protection bit lock bit can be reset to 1 only by taking the device through a power-up or hardware reset.

Common Flash Interface

The common Flash interface (CFI) is a JEDEC-approved, standardized data structure that can be read from the Flash memory device. It allows a system's software to query the device to determine various electrical and timing parameters, density information, and functions supported by the memory. The system can interface easily with the device, enabling the software to upgrade itself when necessary.

When the READ CFI QUERY command is issued, the device enters CFI query mode and the data structure is read from memory. The following tables show the addresses (A-1, A[7:0]) used to retrieve the data. The query data is always presented on the lowest order data outputs (DQ[7:0]), and the other data outputs (DQ[15:8]) are set to 0.

Table 23: Query Structure Overview

Note 1 applies to the entire table

Add	ress		
x16	х8	Subsection Name	Description
10h	20h	CFI query identification string	Command set ID and algorithm data offset
1Bh	36h	System interface information	Device timing and voltage information
27h	4Eh	Device geometry definition	Flash device layout
40h	80h	Primary algorithm-specific extended query table	Additional information specific to the primary algorithm (optional)

Note: 1. Query data are always presented on the lowest order data outputs (DQ[7:0]). DQ[15:8] are set to 0.

Table 24: CFI Query Identification String

Note 1 applies to the entire table

Add	ress			
x16	х8	Data	Description	Value
10h	20h	0051h	Query unique ASCII string "QRY"	"Q"
11h	22h	0052h		"R"
12h	24h	0059h		"Y"
13h	26h	0002h	Primary algorithm command set and control interface ID code 16-bit ID	_
14h	28h	0000h	code defining a specific algorithm	
15h	2Ah	0040h	Address for primary algorithm extended query table (see the Primary Algo-	P = 40h
16h	2Ch	0000h	rithm-Specific Extended Query Table)	
17h	2Eh	0000h	Alternate vendor command set and control Interface ID code second ven-	_
18h	30h	0000h	dor-specified algorithm supported	
19h	32h	0000h	Address for alternate algorithm extended query table	_
1Ah	34h	0000h		

Note: 1. Query data are always presented on the lowest order data outputs (DQ[7:0]). DQ[15:8] are set to 0.

Table 25: CFI Query System Interface Information

Note 1 applies to the entire table

Add	lress			
x16	х8	Data	Description	Value
1Bh	36h	0027h	V _{CC} logic supply minimum program/erase voltage Bits[7:4] BCD value in volts Bits[3:0] BCD value in 100mV	2.7V
1Ch	38h	0036h	V _{CC} logic supply maximum program/erase voltage Bits[7:4] BCD value in volts Bits[3:0] BCD value in 100mV	3.6V
1Dh	3Ah	00B5h	V _{PPH} (programming) supply minimum program/erase voltage Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV	11.5V
1Eh	3Ch	00C5h	V _{PPH} (programming) supply maximum program/erase voltage Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV	12.5V
1Fh	3Eh	0004h	Typical timeout for single byte/word program = 2 ⁿ µs	16µs
20h	40h	0009h	Typical timeout for maximum size buffer program = 2 ⁿ µs	512µs
21h	42h	0009h	Typical timeout per individual block erase = 2 ⁿ ms	0.5s
22h	44h	000Fh	Typical timeout for full chip erase = 2 ⁿ ms	32Mb: 33s
		0010h		64Mb: 66s
		0011h		128Mb: 131s
23h	46h	0004h	Maximum timeout for byte/word program = 2 ⁿ times typical	256µs
24h	48h	0002h	Maximum timeout for buffer program = 2 ⁿ times typical	2048µs
25h	4Ah	0003h	Maximum timeout per individual block erase = 2 ⁿ times typical	4s
26h	4Ch	0002h	Maximum timeout for chip erase = 2 ⁿ times typical	32Mb: 131s
		0002h		64Mb: 262s
		0002h		128Mb: 524s

Note: 1. The values in this table are valid for all packages.

Table 26: Device Geometry Definition

Add	Address			
x16	х8	Data	Description	Value
27h	4Eh	0016h	Device size = 2 ⁿ in number of bytes	4MB
		0017h		8MB
		0018h		16MB
28h	50h	0002h	Flash device interface code description	x8, x16 asynchro-
29h	52h	0000h		nous
2Ah	54h	0008h ¹	Maximum number of bytes in multi-byte program or page = 2 ⁿ	256
2Bh	56h	0000h		

Table 26: Device Geometry Definition (Continued)

Add	lress				
x16	х8	Data	Description	Value	
2Ch	58h	(See table below)	Number of erase block regions. It specifies the number of regions containing contiguous erase blocks of the same size. 01h = Uniform device 02h = Boot device	-	
2Dh	5Ah	(See table	Erase block region 1 information	_	
2Eh	5Ch	below)	Bits[15:0] = y, y + 1 = Number of identical-size erase blocks		
2Fh	5Eh		Bits[31:16] = z, block size in region 1 is z x 256 bytes		
30h	60h				
31h	62h	(See table	Erase block region 2 information	-	
32h	64h	below)	Bits[15:0] = y, y + 1 = Number of identical-size erase blocks		
33h	66h		Bits[31:16] = z, block size in region 1 is z x 256 bytes		
34h	68h				
35h	6Ah	0000h	Erase block region 3 information	0	
36h	6Ch	0000h			
37h	6Eh	0000h			
38h	70h	0000h			
39h	72h	0000h	Erase block region 4 information	0	
3Ah	74h	0000h			
3Bh	76h	0000h			
3Ch	78h	0000h			

Note: 1. The value at 2Ah in the CFI region is set to 08h (256 bytes) due to compatibility issues. The maximum 256-word program buffer can be used to optimize system program performance.

Table 27: Erase Block Region Information

		32Mb				128Mb	
Address	Тор	Bottom	Uniform	Тор	Bottom	Uniform	Uniform
2Ch	02h	02h	01h	02h	02h	01h	01h
2Dh	07h	07h	3Fh	07h	07h	7Fh	7Fh
2Eh	00h	00h	00h	00h	00h	00h	00h
2Fh	20h	20h	00h	20h	20h	00h	00h
30h	00h	00h	01h	00h	00h	01h	02h
31h	3Eh	3Eh	00h	7Eh	7Eh	00h	00h
32h	00h	00h	00h	00h	00h	00h	00h
33h	00h	00h	00h	00h	00h	00h	00h
34h	01h	01h	00h	01h	01h	00h	00h

Table 28: Primary Algorithm-Specific Extended Query Table

Note 1 applies to the entire table

Address				
x16	х8	Data	Description	Value
40h	80h	0050h	Primary algorithm extended query table unique ASCII string "PRI"	"P"
41h	82h	0052h		"R"
42h	84h	0049h		" "
43h	86h	0031h	Major version number, ASCII	"1"
44h	88h	0033h	Minor version number, ASCII	"3"
45h	8Ah	0018h	Address sensitive unlock (bits[1:0]): 00 = Required 01 = Not required Silicon revision number (bits[7:2])	Required
46h	8Ch	0002h	Erase suspend: 00 = Not supported 01 = Read only 02 = Read and write	2
47h	8Eh	0001h	Block protection: 00 = Not supported x = Number of blocks per group	1
48h	90h	0000h	Temporary block unprotect: 00 = Not supported 01 = Supported	Not supported
49h	92h	0008h	Block protect/unprotect: 08 = M29EWH/M29EWL	8
4Ah	94h	0000h	Simultaneous operations: Not supported	n/a
4Bh	96h	0000h	Burst mode: 00 = Not supported 01 = Supported	Not supported
4Ch	98h	0002h	Page mode: 00 = Not supported 01 = 8-word page 02 = 8-word page 03 = 16-word page	8-word page
4Dh	9Ah	00B5h	V _{PPH} supply minimum program/erase voltage: Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV	11.5V
4Eh	9Ch	00C5h	V _{PPH} supply maximum program/erase voltage: Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV	12.5V



Table 28: Primary Algorithm-Specific Extended Query Table (Continued)

Note 1 applies to the entire table

Add	Address			
x16	х8	Data	Description	Value
4Fh	9Eh	00xxh	Top/bottom boot block flag: xx = 02h: Bottom boot device, HW protection for bottom two blocks xx = 03h: Top boot device, HW protection for top two blocks xx = 04h: Uniform device, HW protection for lowest block xx = 05h: Uniform device, HW protection for highest block	Device type (bot- tom boot, top boot, uniform)
50h	A0h	0001h	Program suspend: 00 = Not supported 01 = supported	Supported

Note: 1. The values in this table are valid for both packages.

Power-Up and Reset Characteristics

Table 29: Power-Up Specifications

	Syr	nbol			
Parameter	Legacy	JEDEC	Min	Unit	Notes
V _{CC} HIGH to V _{CCQ} HIGH	_	^t VCHVCQH	0	μs	1
V _{CC} HIGH to rising edge of RST#	tVCS	^t VCHPH	60	μs	2
V _{CCQ} HIGH to rising edge of RST#	tVIOS	tVCQHPH	0	μs	2
RST# HIGH to chip enable LOW	^t RH	^t PHEL	50	ns	
RST# HIGH to write enable LOW	_	^t PHWL	150	ns	

- Notes: 1. V_{CC} and V_{CCO} ramps must be synchronized during power-up.
 - 2. If RST# is not stable for ^tVCS or ^tVIOS, the device will not allow any READ or WRITE operations, and a hardware reset is required.

Figure 14: Power-Up Timing

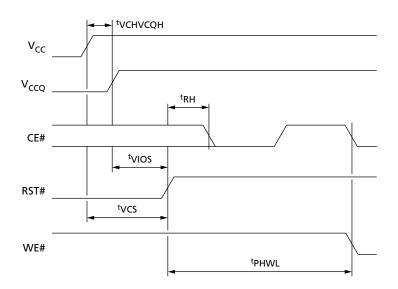




Table 30: Reset AC Specifications

	Symbol					
Condition/Parameter	Legacy	JEDEC	Min	Max	Unit	Notes
RST# LOW to read mode during program or erase	^t READY	^t PLRH	_	25	μs	1
RST# pulse width	^t RP	^t PLPH	100	_	ns	
RST# HIGH to CE# LOW, OE# LOW	^t RH	^t PHEL, ^t PHGL	50	-	ns	1
RST# LOW to standby mode during read mode	^t RPD	_	10	-	μs	
RST# LOW to standby mode during program or erase			50	_	μs	
RY/BY# HIGH to CE# LOW, OE# LOW	^t RB	^t RHEL, ^t RHGL	0	_	ns	1

Note: 1. Sampled only; not 100% tested.

Figure 15: Reset AC Timing - No PROGRAM/ERASE Operation in Progress

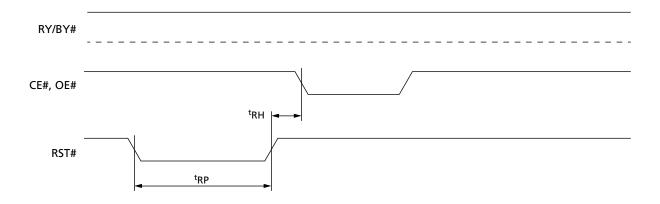
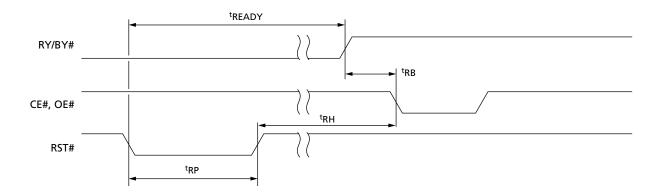


Figure 16: Reset AC Timing During PROGRAM/ERASE Operation



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Absolute Ratings and Operating Conditions

Absolute Ratings and Operating Conditions

Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions outside those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may adversely affect reliability.

Table 31: Absolute Maximum/Minimum Ratings

Parameter	Symbol	Min	Max	Units	Notes
Temperature under bias	T _{BIAS}	-40	85	°C	
Storage temperature	T _{STG}	-65	125	°C	
Input/output voltage	V _{IO}	-0.6	V _{CC} + 0.6	V	1, 2
Supply voltage	V _{CC}	-2	5.6	V	1, 2
Input/output supply voltage	V _{CCQ}	-2	5.6	V	1, 2
Program voltage	V _{PPH}	-2	14.5	V	1, 2, 3

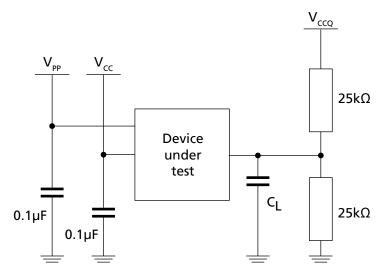
Notes:

- 1. During signal transitions, minimum voltage may undershoot to -2V during periods less than 20ns.
- 2. During signal transitions, maximum voltage may overshoot to V_{CC} + 2V for periods less than 20ns.
- 3. $V_{\mbox{\footnotesize{PPH}}}$ must not remain at 12V for more than 80 hours cumulative.

Table 32: Operating Conditions

Parameter	Symbol	Min	Max	Unit
Supply voltage	V _{CC} 2.7		3.6	V
Input/output supply voltage ($V_{CCQ} \le V_{CC}$)	V _{CCQ}	1.65	3.6	V
Program voltage	V _{PP}	-0.6	12.5	V
Ambient operating temperature	T _A	-40	85	°C
Load capacitance	C _L	30		pF
Input rise and fall times	_	_	2.5	ns
Input pulse voltages	_	0 to V _{CCQ}		V
Input and output timing reference voltages	_	V _{CCQ} /2		V

Figure 17: AC Measurement Load Circuit



Note: 1. C_L includes jig capacitance.

Figure 18: AC Measurement I/O Waveform

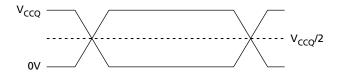


Table 33: Input/Output Capacitance

Parameter	Symbol	Test Condition	Min	Max	Unit
Input capacitance	C _{IN}	$V_{IN} = 0V$	2	7	pF
Output capacitance	C _{OUT}	V _{OUT} = 0V	2	5	pF

DC Characteristics

Table 34: DC Current Characteristics

Parameter		Symbol	Cond	itions	Min	Тур	Max	Unit	Notes
Input leakage	current	ILI	0V ≤ V ₁	_N ≤ V _{CC}	_	_	±1	μΑ	1
Output leakag	ge current	I _{LO}	0V ≤ V _O	_{UT} ≤ V _{CC}	_	_	±1	μΑ	
V _{CC} read current	Random read	I _{CC1}	$CE# = V_{IL}, OE# = V_{IH},$ $f = 5 \text{ MHz}$		-	20	25	mA	
	Page read		$CE# = V_{IL}, OE# = V_{IH},$ $f = 13 \text{ MHz}$		-	12	16	mA	
V _{CC} standby	128Mb	I _{CC2}	$CE# = V_{CCQ} \pm 0.2V,$		_	50	120	μΑ	
current	64Mb		RST# = $V_{CCQ} \pm 0.2V$		_	35	120	μΑ	
	32Mb				_	35	120	μΑ	
V _{CC} program/e check current	erase/blank	I _{CC3}	Program/ $V_{PP}/WP# = V_{IL}$ erase or V_{IH}		-	35	50	mA	2
			controller $V_{PP}/WP\# = V_{PPH}$		-	26	33	mA	
V _{PP} current	Read	I _{PP1}	V _{PP} /WP	°# ≤ V _{CC}	-	2	15	μΑ	
	Standby				-	0.2	5	μΑ	
	Reset	I _{PP2}	$RST\# = V_{SS} \pm 0.2V$		-	0.2	5	μΑ	
	PROGRAM operation	I _{PP3}	V _{PP} /WP# = 12V ±5%		-	5	10	mA	
	ongoing		$V_{PP}/WP# = V_{CC}$		-	0.05	0.10	mA	
	ERASE operation	I _{PP4}	V _{PP} /WP# = 12V ±5%		_	5	10	mA	
	ongoing		V _{PP} /WP	2# = V _{CC}	-	0.05	0.10	mA	

Notes: 1. The maximum input leakage current is $\pm 5\mu A$ on the $V_{PP}/WP\#$ pin.

2. Sampled only; not 100% tested.



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash DC Characteristics

Table 35: DC Voltage Characteristics

Parameter	Symbol	Conditions	Min	Тур	Max	Unit	Notes
Input LOW voltage	V _{IL}	V _{CC} ≥ 2.7V	-0.5	_	0.8	V	
Input HIGH voltage	V _{IH}	V _{CC} ≥ 2.7V	V _{CCQ} -0.4	_	V _{CCQ} +0.5	V	1
Output LOW voltage	V _{OL}	$I_{OL} = 100 \mu A$, $V_{CC} = V_{CC,min}$, $V_{CCQ} = V_{CCQ,min}$	_	-	0.2	V	
Output HIGH voltage	V _{OH}	$I_{OH} = 100 \mu A,$ $V_{CC} = V_{CC,min},$ $V_{CCQ} = V_{CCQ,min}$	V _{CCQ} - 0.2	-	1	V	
Voltage for V _{PP} /WP# program acceleration	V _{PPH}	-	11.5	_	12.5	V	
V _{PP} logic level	V _{PPL}		2.7	_	3.6	V	
Program/erase lockout supply voltage	V _{LKO}	-	2.3	ı	_	V	2

Notes: 1. If V_{CCQ} range is 2.7v~3.6v, V_{IH} Min is 2v.

2. Sampled only; not 100% tested.

Read AC Characteristics

Table 36: Read AC Characteristics

	Symbol							
Parameter	Legacy	JEDEC	Condition	Package	Min	Max	Unit	Notes
Address valid to next address valid	^t RC	^t AVAV	CE# = V _{IL} ,	BGA	60	_	ns	
			OE# = V _{IL}	TSOP	70	_	ns	
Address valid to output valid	^t ACC	^t AVQV	AVQV $CE\# = V_{IL}$, $OE\# = V_{IL}$	BGA	-	60	ns	
				TSOP	_	70	ns	
Address valid to output valid	^t PAGE	tAVQV1	CE# = V _{IL} ,	BGA	_	25	ns	
(page)			OE# = V _{IL}	TSOP	-	25	ns	
CE# LOW to output transition	^t LZ	^t ELQX	OE# = V _{IL}	BGA	0	_	ns	1
				TSOP	0	_	ns	1
CE# LOW to output valid	^t E	^t ELQV	OE# = V _{IL}	BGA	_	60	ns	
				TSOP	_	70	ns	
OE# LOW to output transition	^t OLZ	^t GLQX	CE# = V _{IL}	BGA	0	_	ns	1
				TSOP	0	_	ns	1
OE# LOW to output valid	^t OE	^t GLQV	CE# = V _{IL}	BGA	_	25	ns	
				TSOP	_	25	ns	
CE# HIGH to output High-Z	HIGH to output High-Z ^t HZ ^t EHQZ OE# =	OE# = V _{IL}	BGA	_	20	ns	1	
				TSOP	_	20	ns	1
OE# HIGH to output High-Z	^t DF	^t GHQZ	CE# = V _{IL}	BGA	_	15	ns	1
				TSOP	_	15	ns	1
CE#, OE#, or address transition to	tOH	^t EHQX,	_	BGA	0	_	ns	
output transition		^t GHQX, ^t AXQX		TSOP	0	-	ns	
CE# to BYTE# LOW	^t ELFL	^t ELBL	_	BGA	_	10	ns	
				TSOP	_	10	ns	
CE# to BYTE# HIGH	tELFH	^t ELBH	_	BGA	-	10	ns	
				TSOP	_	10	ns	
BYTE# LOW to output valid	^t FLQV	^t BLQV	_	BGA	-	1	μs	
				TSOP	-	1	μs	
BYTE# HIGH to output valid	^t FHQV	^t BHQV	_	BGA	-	1	μs	
				TSOP	-	1	μs	
BYTE# LOW to output in High-Z	^t FLQZ	^t BLQZ	_	BGA	_	1	μs	
				TSOP	_	1	μs	

Note: 1. Sampled only; not 100% tested.



Figure 19: Random Read AC Timing (8-Bit Mode)

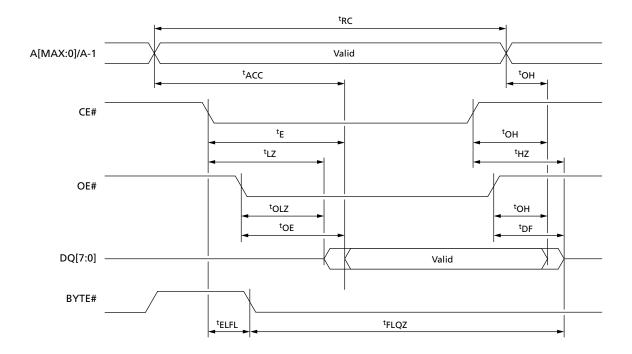


Figure 20: Random Read AC Timing (16-Bit Mode)

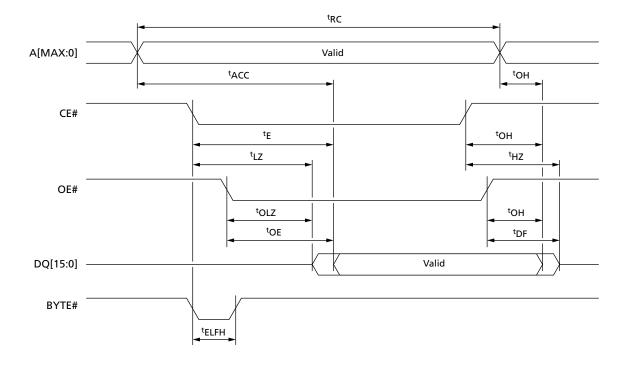




Figure 21: BYTE# Transition Read AC Timing

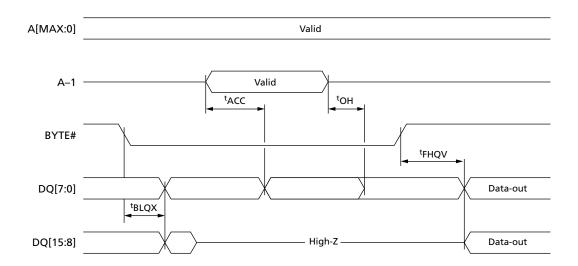
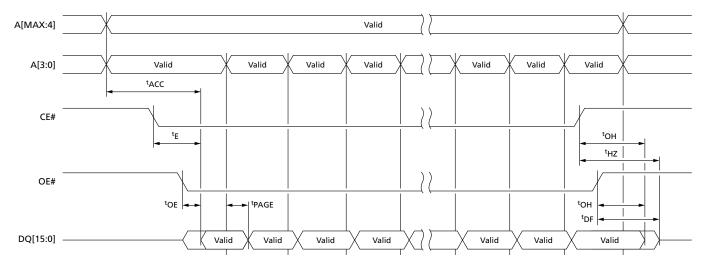


Figure 22: Page Read AC Timing (16-Bit Mode)



Note: 1. Page size is 8 words (16 bytes) and is addressed by address inputs A[2:0] in x16 bus mode and A[2:0] plus DQ15/A–1 in x8 bus mode.

Write AC Characteristics

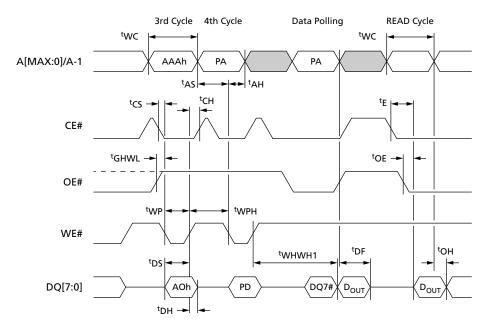
Table 37: WE#-Controlled Write AC Characteristics

Parameter								
	Syn	nbol	Package	Min	Тур	Max	Unit	Notes
	Legacy	JEDEC						
Address valid to next address valid	tWC	^t AVAV	BGA	60	_	-	ns	
			TSOP	70	_	_	ns	
CE# LOW to WE# LOW	^t CS	^t ELWL	BGA	0	-	-	ns	
			TSOP	0	-	-	ns	
WE# LOW to WE# HIGH	^t WP	tWLWH	BGA	35	-	-	ns	
			TSOP	35	-	_	ns	
Input valid to WE# HIGH	^t DS	^t DVWH	BGA	30	-	_	ns	
			TSOP	30	-	_	ns	
WE# HIGH to input transition	^t DH	tWHDX	BGA	0	-	_	ns	
			TSOP	0	_	_	ns	
WE# HIGH to CE# HIGH	^t CH	tWHEH	BGA	0	_	-	ns	
			TSOP	0	_	-	ns	
WE# HIGH to WE# LOW	^t WPH	tWHWL	BGA	20	_	_	ns	
			TSOP	20	_	_	ns	
Address valid to WE# LOW	^t AS	^t AVWL	BGA	0	_	-	ns	
			TSOP	0	_	-	ns	
WE# LOW to address transition	^t AH	tWLAX	BGA	45	_	-	ns	
			TSOP	45	_	-	ns	
OE# HIGH to WE# LOW	_	^t GHWL	BGA	0	_	-	ns	
			TSOP	0	-	_	ns	
WE# HIGH to OE# LOW	^t OEH	^t WHGL	BGA	0	_	_	ns	
			TSOP	0	-	_	ns	
Program/erase valid to RY/BY# LOW	^t BUSY	tWHRL	BGA	_	-	90	ns	1
			TSOP	_	-	90	ns	1
V _{CC} HIGH to CE# LOW	tVCS	tVCHEL	BGA	60	-	-	μs	
			TSOP	60	_	_	μs	

Note: 1. Sampled only; not 100% tested.

32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Write AC Characteristics

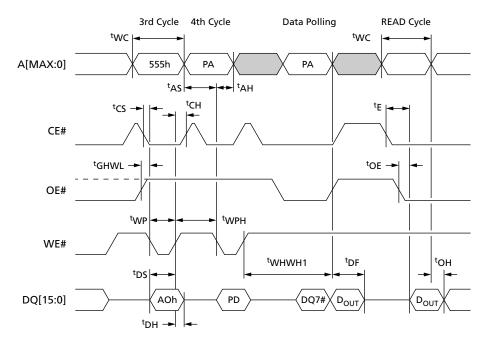
Figure 23: WE#-Controlled Program AC Timing (8-Bit Mode)



Notes:

- 1. Only the third and fourth cycles of the PROGRAM command are represented. The PRO-GRAM command is followed by checking of the status register data polling bit and by a READ operation that outputs the data (D_{OUT}) programmed by the previous PROGRAM command.
- 2. PA is the address of the memory location to be programmed. PD is the data to be programmed.
- 3. DQ7 is the complement of the data bit being programmed to DQ7 (See Data Polling Bit [DQ7]).
- 4. See the following tables for timing details: Read AC Characteristics, WE#-Controlled Write AC Characteristics, and CE#-Controlled Write AC Characteristics.

Figure 24: WE#-Controlled Program AC Timing (16-Bit Mode)



- Notes: 1. Only the third and fourth cycles of the PROGRAM command are represented. The PRO-GRAM command is followed by checking of the status register data polling bit and by a READ operation that outputs the data (D_{OUT}) programmed by the previous PROGRAM command.
 - 2. PA is the address of the memory location to be programmed. PD is the data to be programmed.
 - 3. DQ7 is the complement of the data bit being programmed to DQ7 (See Data Polling Bit [DQ7]).
 - 4. See the following tables for timing details: Read AC Characteristics, WE#-Controlled Write AC Characteristics, and CE#-Controlled Write AC Characteristics.

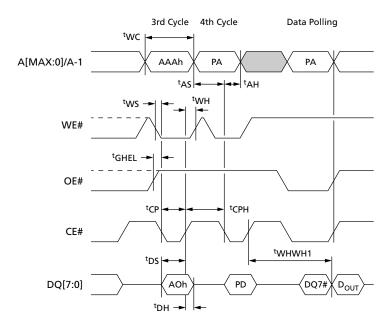


32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Write AC Characteristics

Table 38: CE#-Controlled Write AC Characteristics

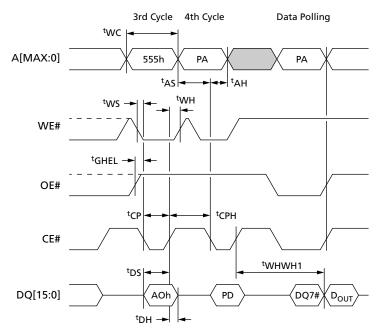
Parameter	Syn	nbol	Package	Min	Тур	Max	Unit
	Legacy JEDEC						
Address valid to next address valid	tWC	^t AVAV	BGA	60	_	_	ns
			TSOP	70	_	_	ns
WE# LOW to CE# LOW	tWS	tWLEL	BGA	0	_	_	ns
			TSOP	0	_	_	ns
CE# LOW to CE# HIGH	^t CP	tELEH	BGA	35	_	_	ns
			TSOP	35	_	_	ns
Input valid to CE# HIGH	^t DS	^t DVEH	BGA	30	_	_	ns
			TSOP	30	_	_	ns
CE# HIGH to input transition	^t DH	tEHDX	BGA	0	_	_	ns
			TSOP	0	_	_	ns
CE# HIGH to WE# HIGH	tWH	^t EHWH	BGA	0	_	-	ns
			TSOP	0	_	_	ns
CE# HIGH to CE# LOW	^t CPH	^t EHEL	BGA	20	_	_	ns
			TSOP	20	_	_	ns
Address valid to CE# LOW	^t AS	^t AVEL	BGA	0	_	_	ns
			TSOP	0	_	_	ns
CE# LOW to address transition	^t AH	^t ELAX	BGA	45	_	_	ns
			TSOP	45	_	_	ns
OE# HIGH to CE# LOW	_	^t GHEL	BGA	0	_	_	ns
			TSOP	0	_	_	ns

Figure 25: CE#-Controlled Program AC Timing (8-Bit Mode)



- Notes: 1. Only the third and fourth cycles of the PROGRAM command are represented. The PRO-GRAM command is followed by checking of the status register data polling bit.
 - 2. PA is the address of the memory location to be programmed. PD is the data to be programmed.
 - 3. DQ7 is the complement of the data bit being programmed to DQ7 (See Data Polling Bit [DQ7]).
 - 4. See the following tables for timing details: Read AC Characteristics, WE#-Controlled Write AC Characteristics, and CE#-Controlled Write AC Characteristics.

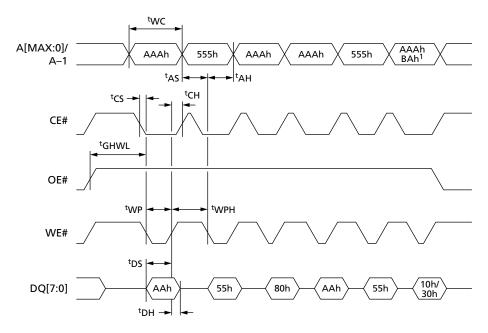
Figure 26: CE#-Controlled Program AC Timing (16-Bit Mode)



- Notes: 1. Only the third and fourth cycles of the PROGRAM command are represented. The PRO-GRAM command is followed by checking of the status register data polling bit.
 - 2. PA is the address of the memory location to be programmed. PD is the data to be programmed.
 - 3. DQ7 is the complement of the data bit being programmed to DQ7 (See Data Polling Bit [DQ7]).
 - 4. See the following tables for timing details: Read AC Characteristics, WE#-Controlled Write AC Characteristics, and CE#-Controlled Write AC Characteristics.



Figure 27: Chip/Block Erase AC Timing (8-Bit Mode)



Notes: 1. For a CHIP ERASE command, the address is 555h, and the data is 10h; for a BLOCK ERASE command, the address is BAd, and the data is 30h.

- 2. BAd is the block address.
- 3. See the following tables for timing details: Read AC Characteristics, WE#-Controlled Write AC Characteristics, and CE#-Controlled Write AC Characteristics.



Accelerated Program, Data Polling/Toggle AC Characteristics

Table 39: Accelerated Program and Data Polling/Data Toggle AC Characteristics

	Symbol				
Parameter	Legacy	JEDEC	Min	Max	Unit
V _{PP} /WP# rising or falling time	_	^t VHVPP	250	-	ns
Valid V _{HH} on V _{PP} /WP# to WE# HIGH	_	tVHHWH	50	_	ns
Address setup time to OE# LOW during toggle bit polling	^t ASO	^t AXGL	15	-	ns
Address hold time from OE# during toggle bit polling	^t AHT	^t GHAX, ^t EHAX	0	-	ns
CE# HIGH during toggle bit polling	^t EPH	tEHEL2	20	-	ns
Output hold time during data and toggle bit polling	^t OEH	^t WHGL2, ^t GHGL2	20	_	ns
Program/erase valid to RY/BY# LOW	^t BUSY	tWHRL	_	90	ns

Note: 1. Sampled only; not 100% tested.

Figure 28: Accelerated Program AC Timing

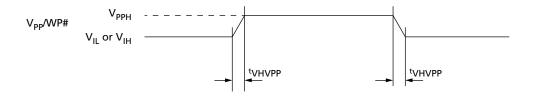
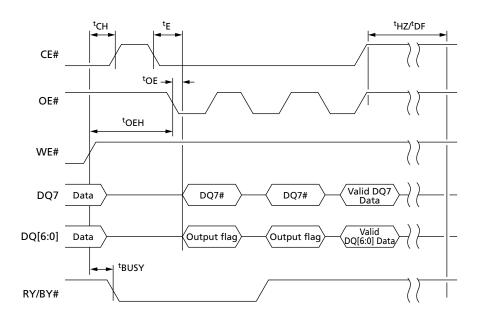


Figure 29: Data Polling AC Timing



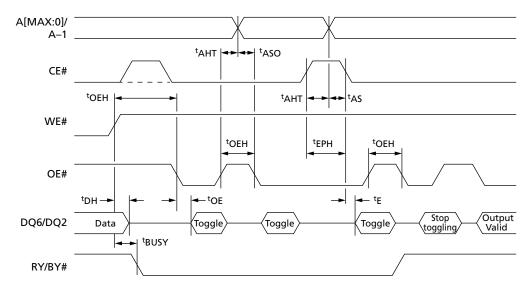


32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Accelerated Program, Data Polling/Toggle AC Characteristics

Notes:

- 1. DQ7 returns a valid data bit when the PROGRAM or ERASE command has completed.
- 2. See the following tables for timing details: Read AC Characteristics, Accelerated Program and Data Polling/Data Toggle AC Characteristics.

Figure 30: Toggle/Alternative Toggle Bit Polling AC Timing (8-Bit Mode)



Notes:

- 1. DQ6 stops toggling when the PROGRAM or ERASE command has completed. DQ2 stops toggling when the CHIP ERASE or BLOCK ERASE command has completed.
- 2. See the following tables for timing details: Read AC Characteristics, Accelerated Program and Data Polling/Data Toggle AC Characteristics.

Electrical Specifications - Program/Erase Characteristics

Table 40: Program/Erase Characteristics

		Buffer						
Parameter		Size	Byte	Word	Min	Typ ^{1, 2}	Max ²	Unit
Block erase Erase suspend latency		_	_	-	_	0.5 20	4 25	s µs
		_	_					
Block erase timeout		_	_	_	50	_	_	μs
Byte program	Single-byte program	_	_	_	_	15	175	μs
	Double-/ quadruple-/ octuple-byte program	_	-	_	_	10	200	μs
	Byte write to buffer program	32	32	_	_	70	200	μs
		64	64	-	_	85	200	μs
		256	256	-	_	160	710	μs
	Effective write to buffer program	32	1	-	_	2.19	6.25	μs
	per byte	64	1	-	_	1.33	3.125	μs
		256	1	-	_	0.625	2.77	μs
Word program	Single-word program	_	_	-	_	15	175	μs
	Word write to buffer program	16	_	16	_	70	200	μs
		32	_	32	_	85	200	μs
		128	_	128	_	160	710	μs
		256	_	256	_	284	1280	μs
	Full buffer program with V _{PPH}	256	_	256	_	160	800	μs
	Effective write to buffer program	16	_	1	_	4.375	12.5	μs
	per word	32	_	1	_	2.66	6.25	μs
		128	_	1	_	1.25	5.55	μs
		256	_	1	_	1.11	5	μs
	Effective full buffer program per word with V _{PPH}	256	1	1	_	0.625	3.125	μs
Program suspend latency		_	_	-	_	20	25	μs
Blank check		_	_	-	_	3.2	_	ms
PROGRAM/ERASE cycles (per block)		_	_	_	100,000	_	_	cycles

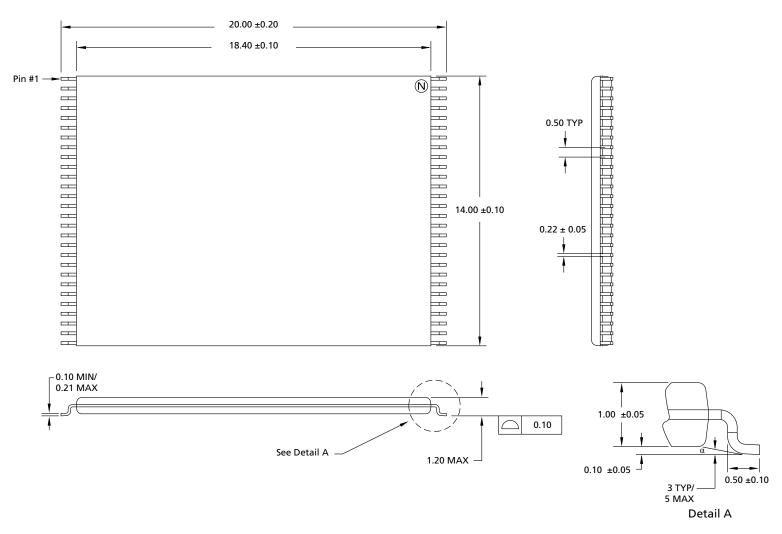
Notes: 1. Typical values measured at room temperature and nominal voltages.

2. Sampled, but not 100% tested.



Package Dimensions

Figure 31: 56-Pin TSOP - 14mm x 20mm

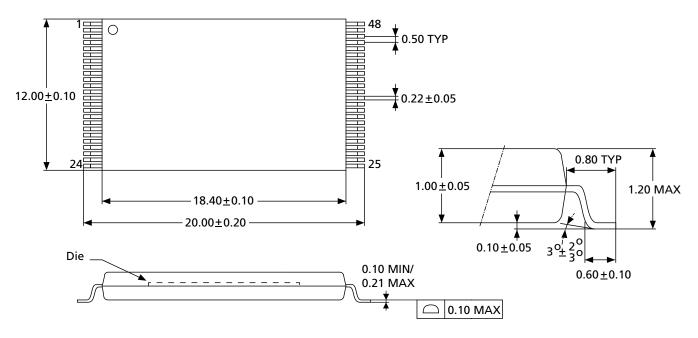


Notes: 1. All dimensions are in millimeters.

2. For the lead width value of 0.22 \pm 0.05, there is also a legacy value of 0.15 \pm 0.05.



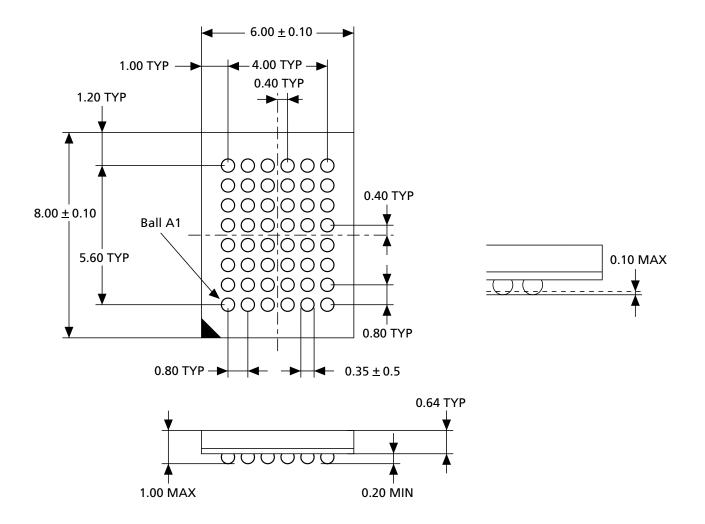
Figure 32: 48-Pin TSOP - 12mm x 20mm



Note: 1. All dimensions are in millimeters.



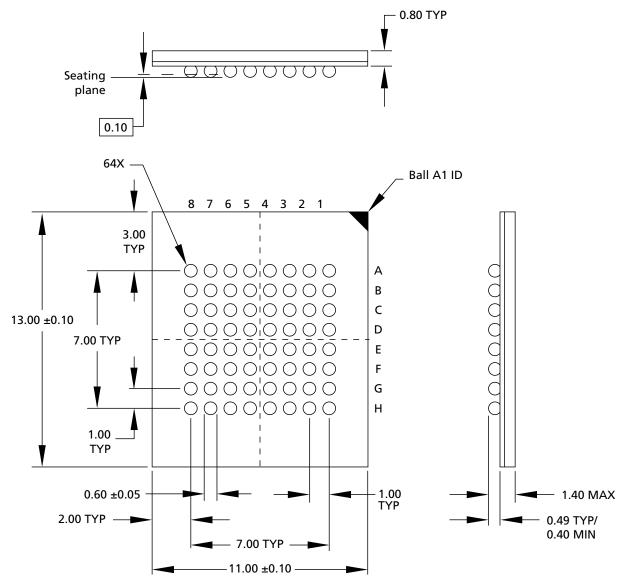
Figure 33: 48-Ball BGA - 6mm x 8mm



Note: 1. All dimensions are in millimeters.



Figure 34: 64-Ball Fortified BGA - 11mm x 13mm



Note: 1. All dimensions are in millimeters.



32Mb, 64Mb, 128Mb: 3V Embedded Parallel NOR Flash Revision History

Revision History

Rev. B - 11/12

- Added text to Signal Descriptions to clarify V_{PP}/WP# and VSS decoupling requirement.
- Added note to DC Voltage Characteristics table to clarify VIH spec.

Rev. A - 08/12

• Initial Micron rebrand release

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This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change, as further product development and data characterization sometimes occur.